

DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.2 Shielded Room
Date : 2011/06/25

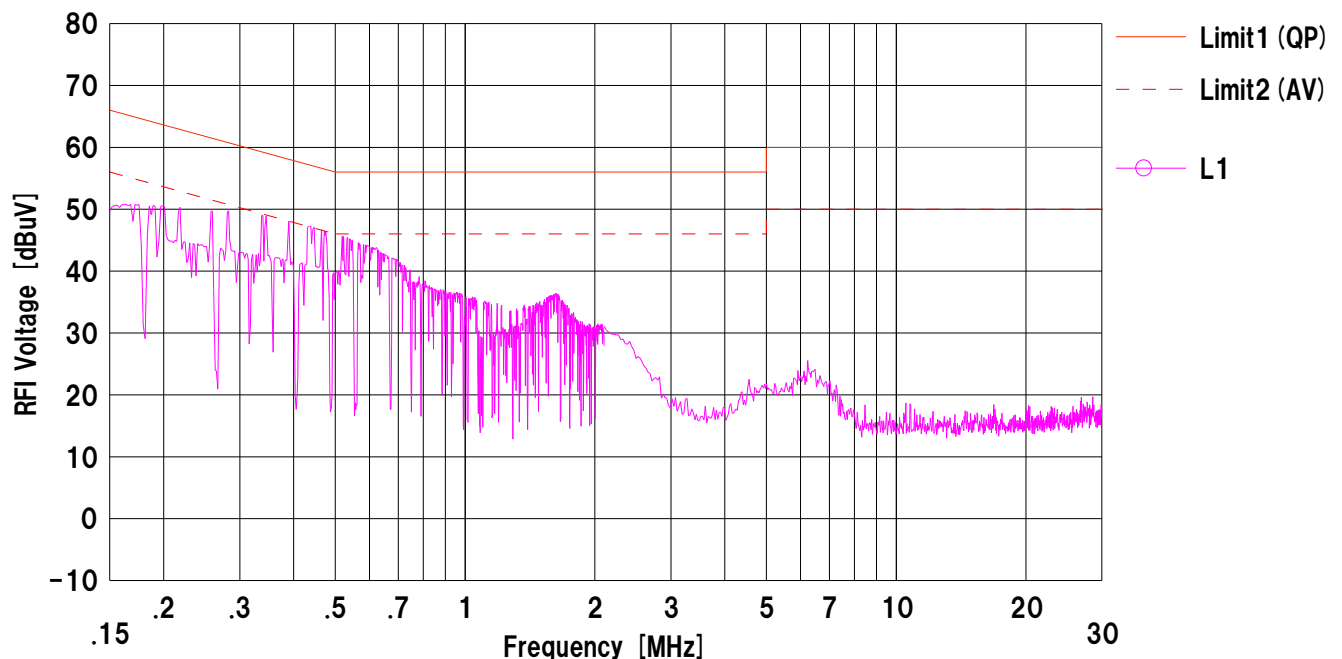
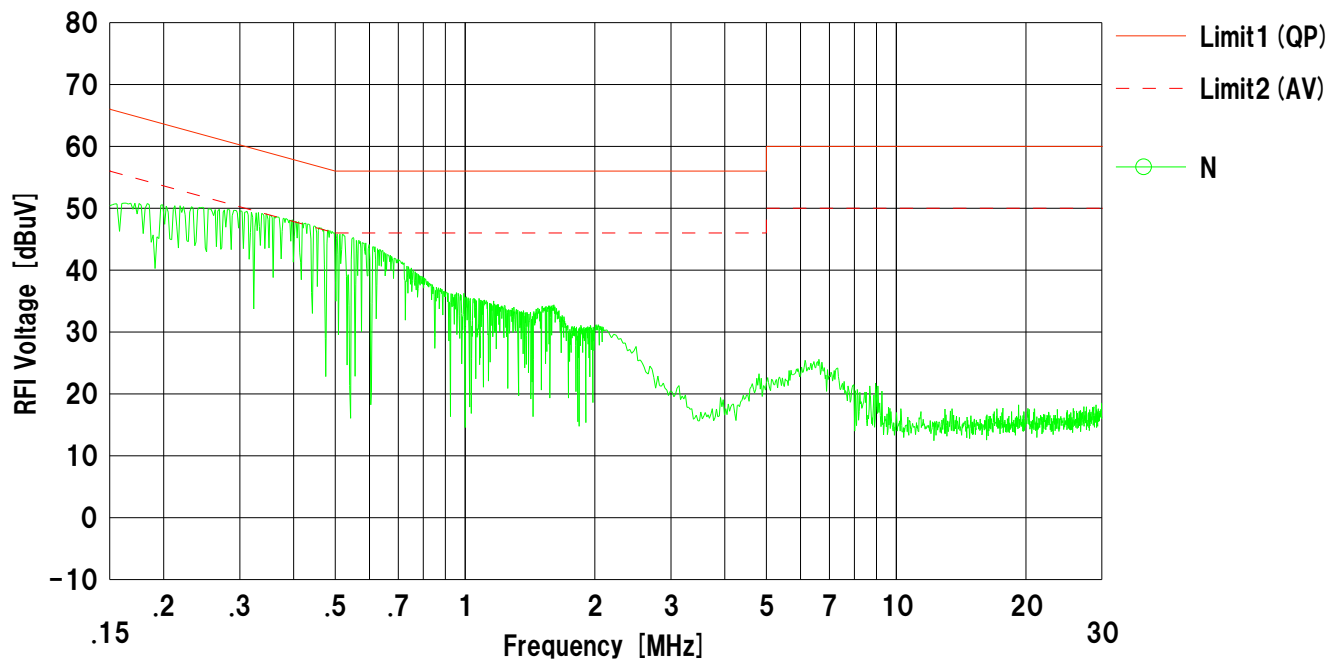
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11a 5180MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



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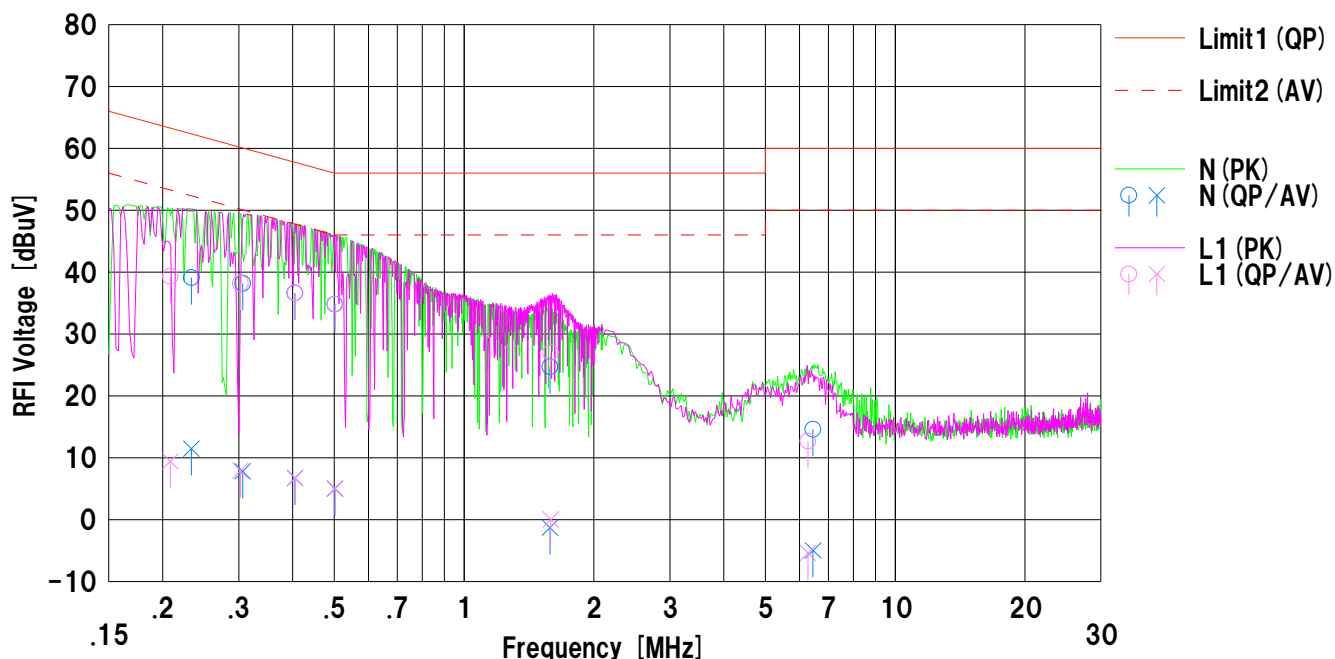
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11a 5200MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



No.	Freq. [MHz]	Reading		C.Fac [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.23314	26.5	-1.1	12.6	39.1	11.5	62.3	52.3	23.2	40.8	N	
2	0.30645	25.5	-4.9	12.7	38.2	7.8	60.0	50.0	21.8	42.2	N	
3	0.40513	23.9	-6.0	12.7	36.6	6.7	57.7	47.7	21.1	41.0	N	
4	0.50121	22.1	-7.7	12.7	34.8	5.0	56.0	46.0	21.2	41.0	N	
5	1.58160	11.9	-14.1	12.8	24.7	-1.3	56.0	46.0	31.3	47.3	N	
6	6.45420	1.5	-18.1	13.1	14.6	-5.0	60.0	50.0	45.4	55.0	N	
7	0.20823	26.7	-3.2	12.6	39.3	9.4	63.2	53.2	23.9	43.8	L1	
8	0.30260	25.5	-4.8	12.7	38.2	7.9	60.1	50.1	21.9	42.2	L1	
9	0.40545	23.9	-6.0	12.7	36.6	6.7	57.7	47.7	21.1	41.0	L1	
10	0.50254	22.1	-7.7	12.7	34.8	5.0	56.0	46.0	21.2	41.0	L1	
11	1.58850	14.2	-12.8	12.8	27.0	0.0	56.0	46.0	29.0	46.0	L1	
12	6.27130	-0.4	-18.5	13.1	12.7	-5.4	60.0	50.0	47.3	55.4	L1	

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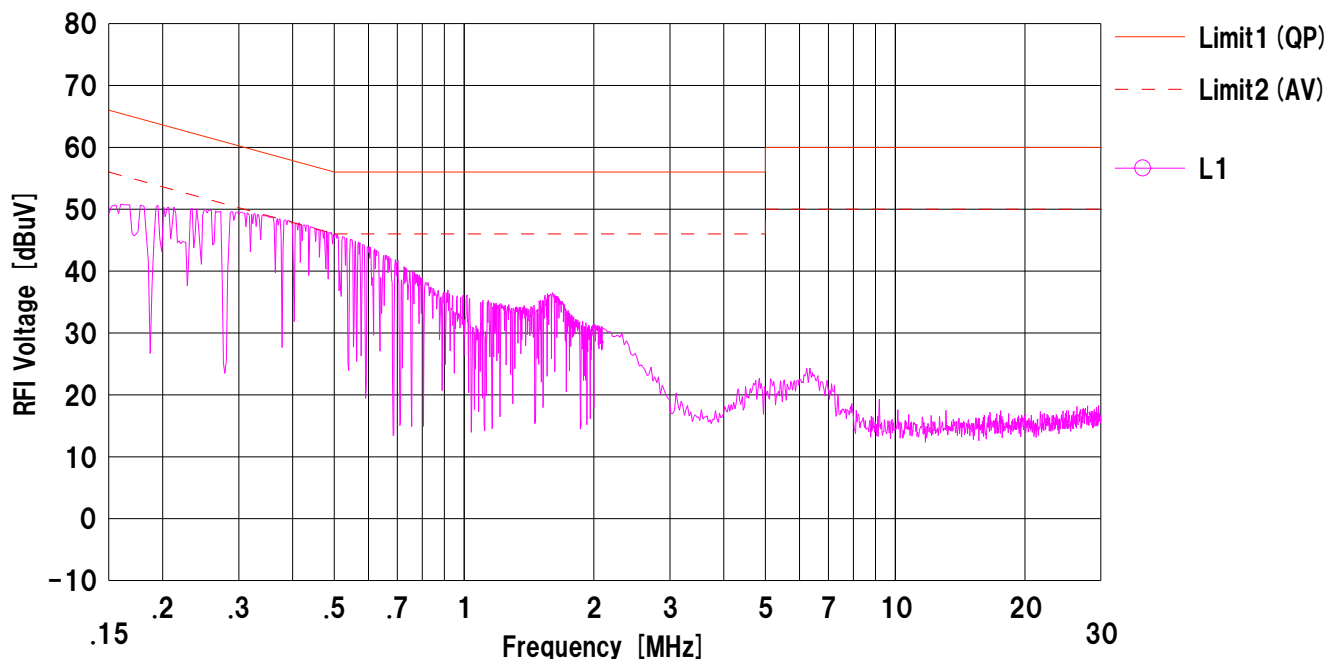
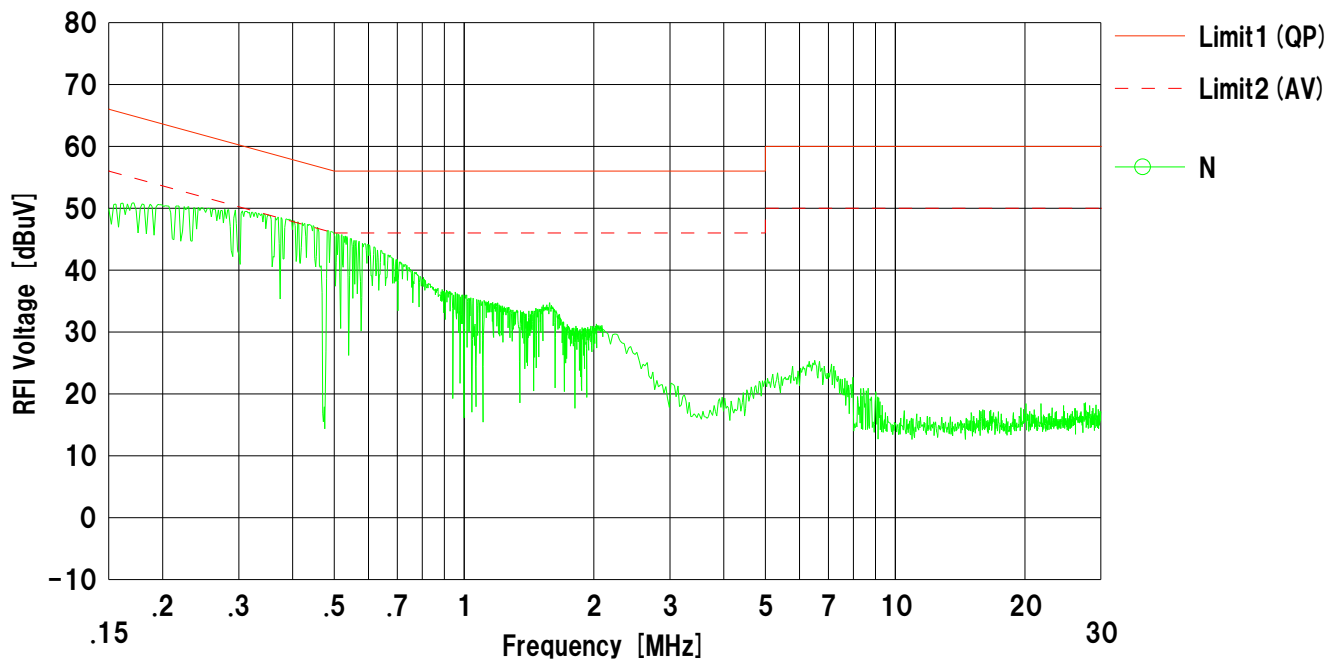
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11a 5240MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



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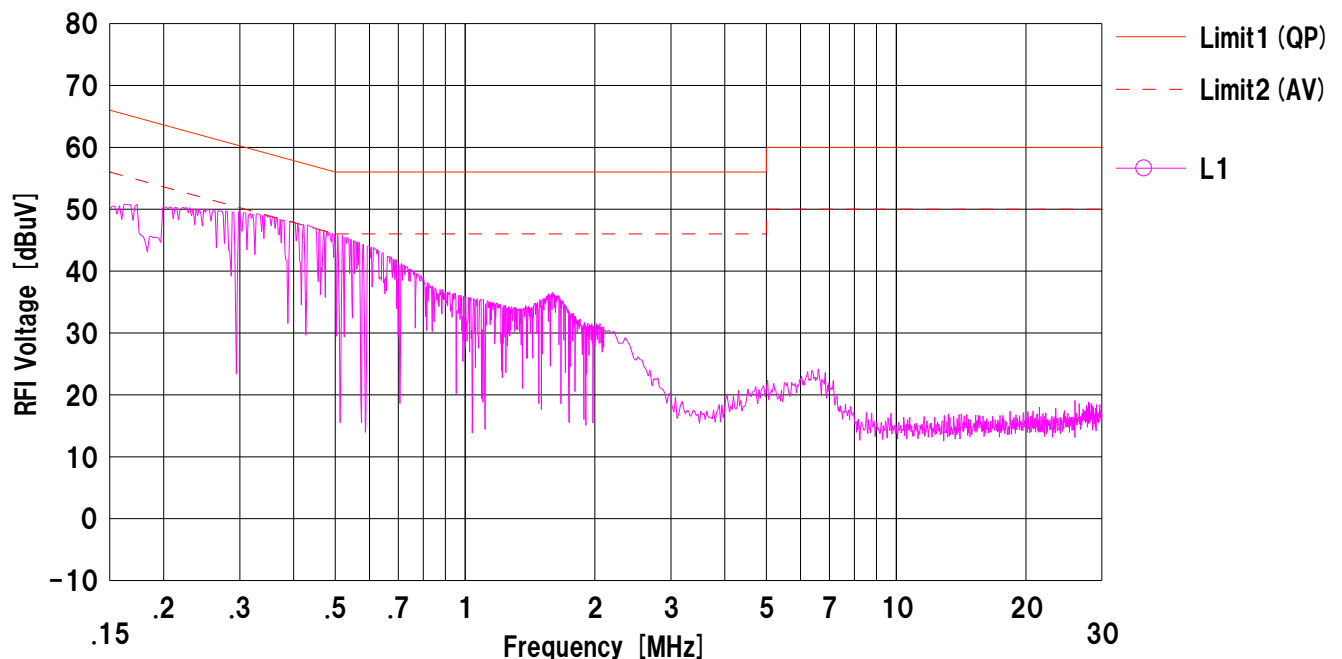
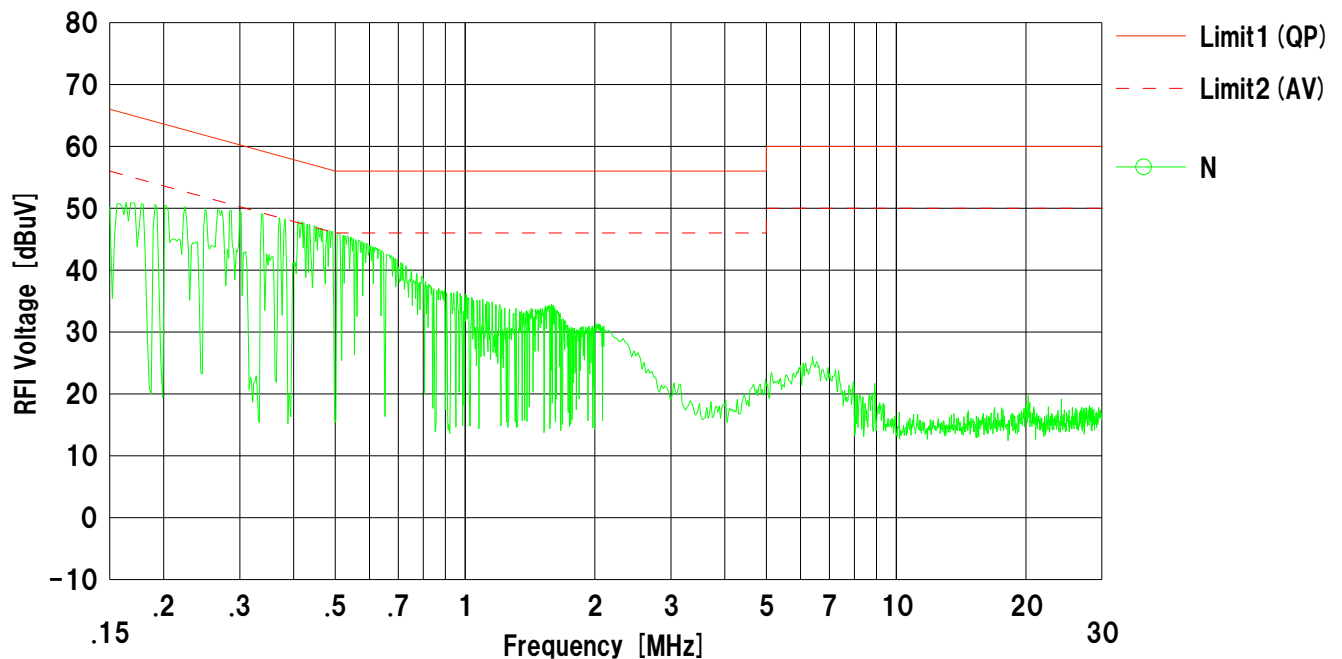
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11a 5260MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.2 Shielded Room
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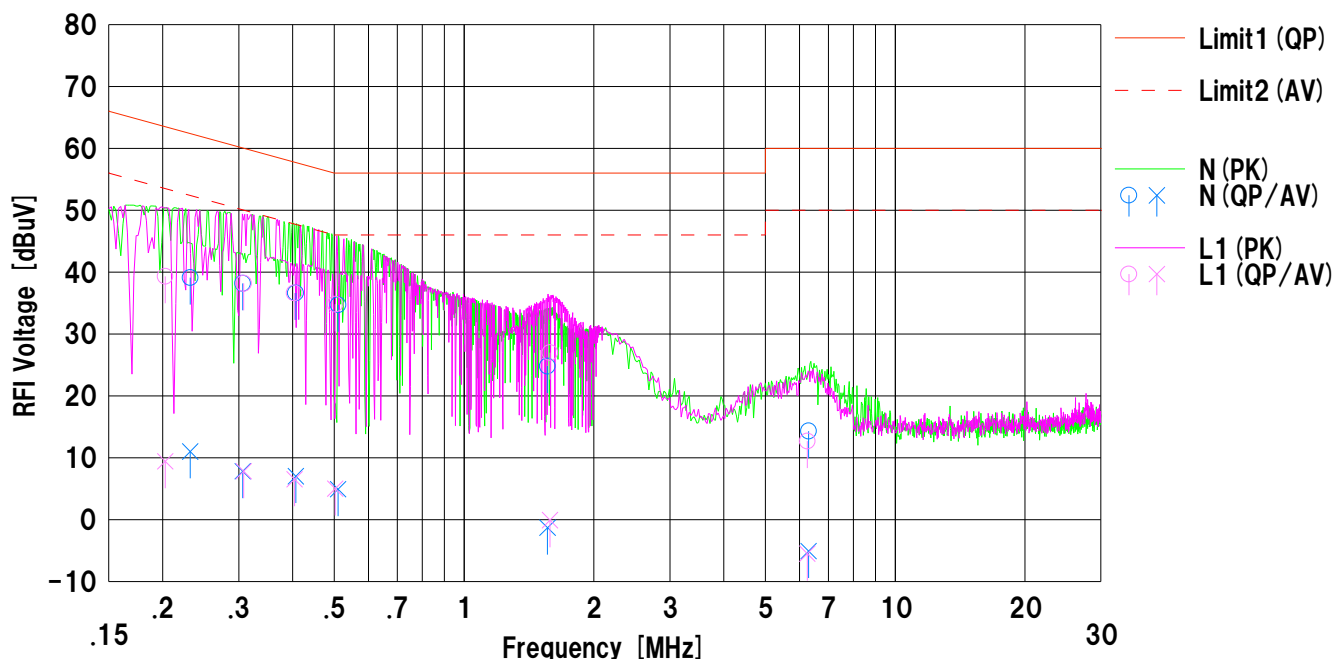
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11a 5280MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



No.	Freq. [MHz]	Reading		C.Fac	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.23155	26.5	-1.6	12.6	39.1	11.0	62.3	52.3	23.2	41.3	N	
2	0.30640	25.5	-4.9	12.7	38.2	7.8	60.0	50.0	21.8	42.2	N	
3	0.40690	23.9	-5.7	12.7	36.6	7.0	57.7	47.7	21.1	40.7	N	
4	0.51010	22.0	-7.8	12.7	34.7	4.9	56.0	46.0	21.3	41.1	N	
5	1.56211	12.0	-14.1	12.8	24.8	-1.3	56.0	46.0	31.2	47.3	N	
6	6.29940	1.2	-18.2	13.1	14.3	-5.1	60.0	50.0	45.7	55.1	N	
7	0.20280	26.7	-3.2	12.6	39.3	9.4	63.4	53.4	24.1	44.0	L1	
8	0.30822	25.5	-4.9	12.7	38.2	7.8	60.0	50.0	21.8	42.2	L1	
9	0.40393	23.9	-6.2	12.7	36.6	6.5	57.7	47.7	21.1	41.2	L1	
10	0.50220	22.1	-7.7	12.7	34.8	5.0	56.0	46.0	21.2	41.0	L1	
11	1.58310	14.2	-12.9	12.8	27.0	-0.1	56.0	46.0	29.0	46.1	L1	
12	6.25550	-0.4	-18.6	13.1	12.7	-5.5	60.0	50.0	47.3	55.5	L1	

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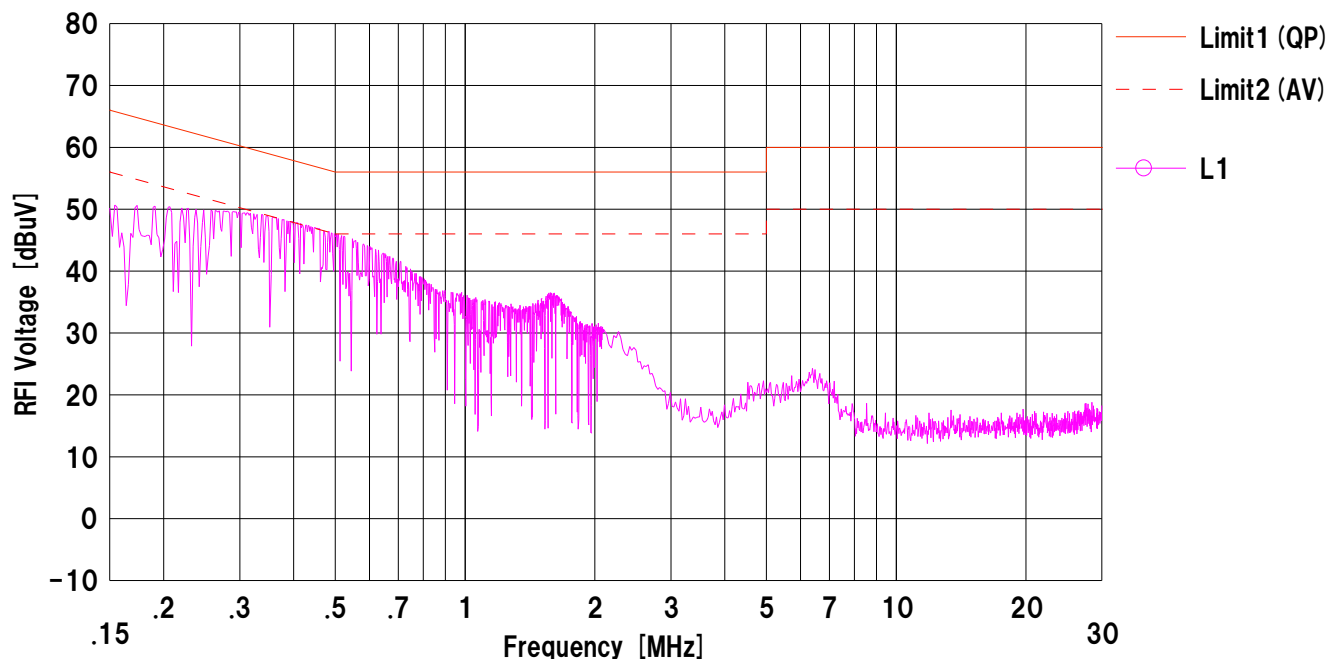
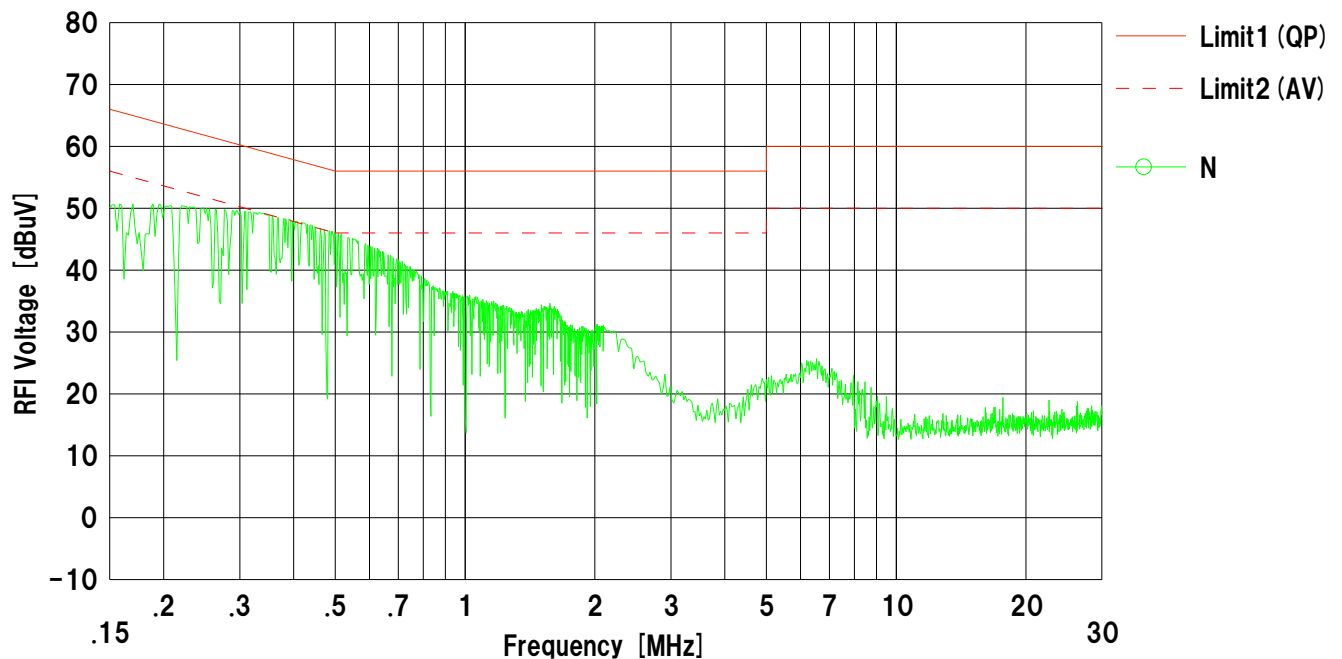
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11a 5320MHz
Report No. : 31CE0052-HO-01-K
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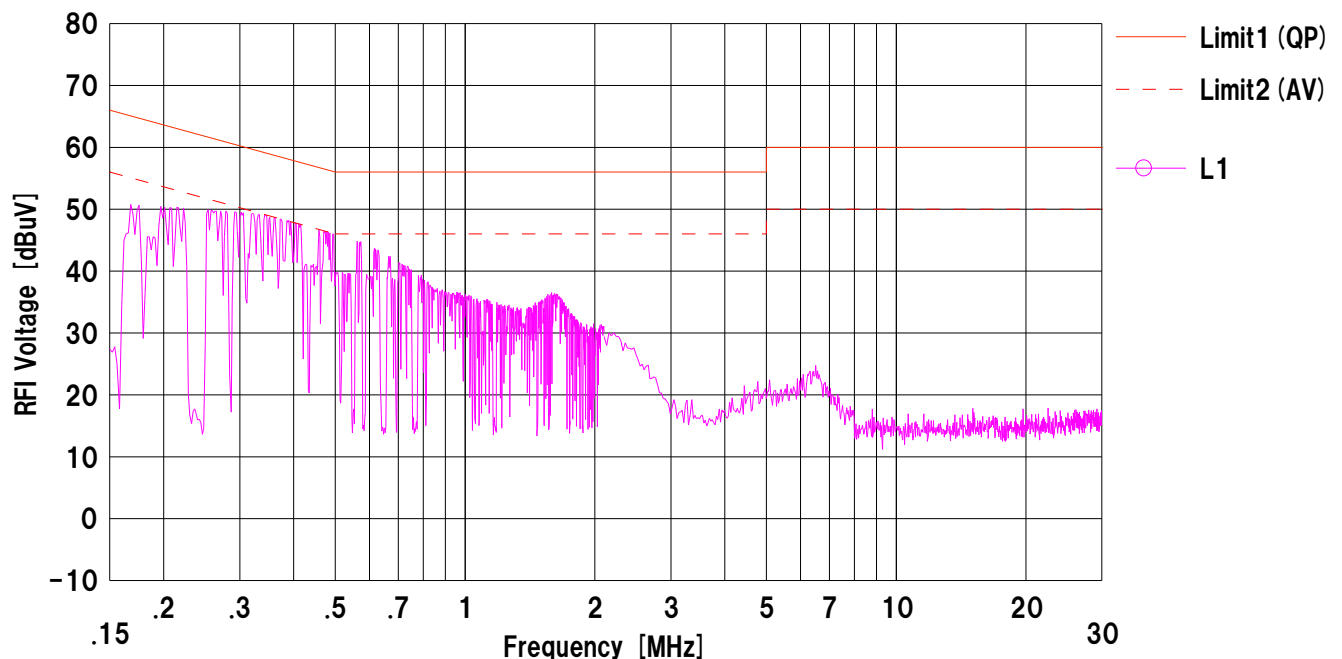
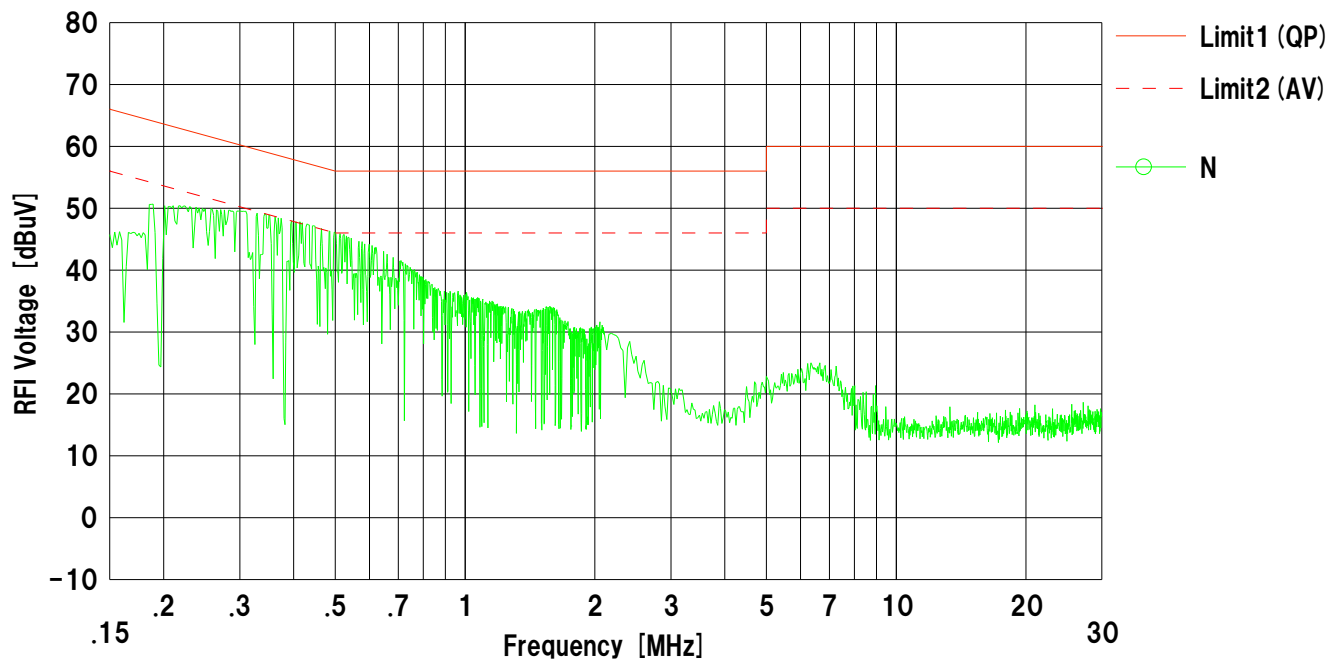
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT20) 5180MHz
Report No. : 31CE0052-H0-01-K
Power : DC3.3V (AC120V/60Hz)
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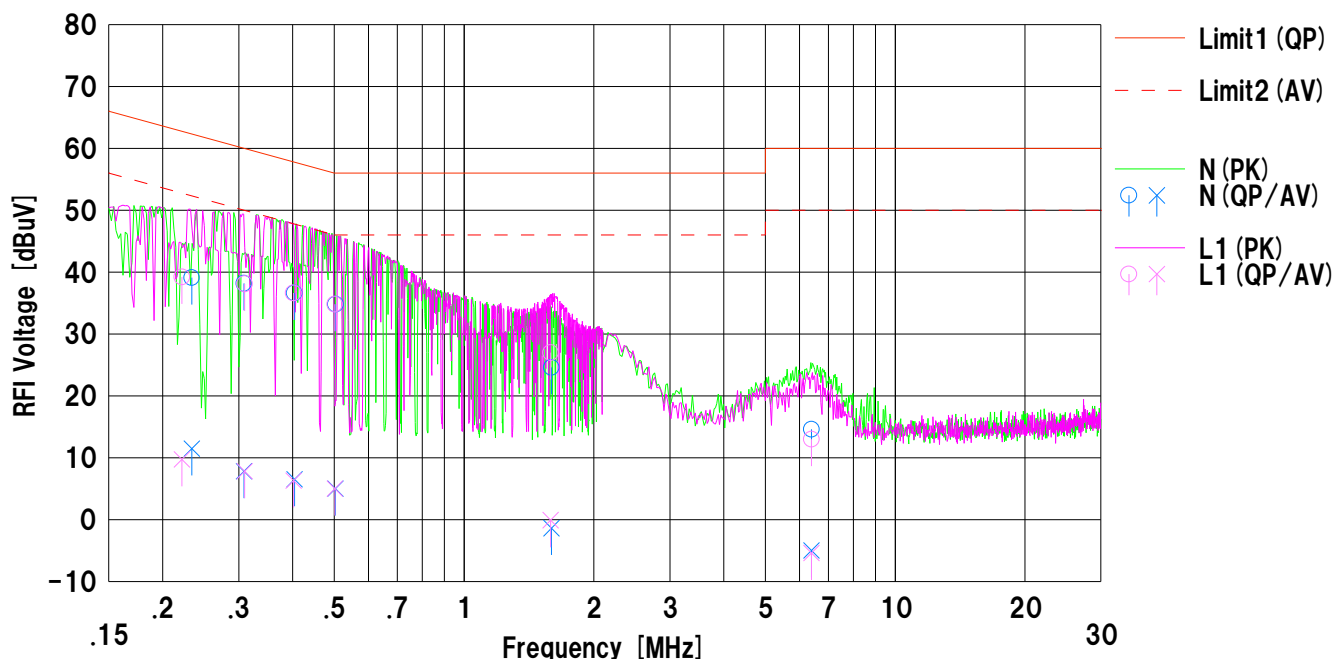
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT20) 5200MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
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Engineer : Akio Hayashi



No.	Freq. [MHz]	Reading		C.Fac [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.23332	26.5	-1.1	12.6	39.1	11.5	62.3	52.3	23.2	40.8	N	
2	0.30829	25.5	-4.9	12.7	38.2	7.8	60.0	50.0	21.8	42.2	N	
3	0.40402	23.9	-6.2	12.7	36.6	6.5	57.7	47.7	21.1	41.2	N	
4	0.50280	22.1	-7.7	12.7	34.8	5.0	56.0	46.0	21.2	41.0	N	
5	1.59456	11.8	-14.2	12.8	24.6	-1.4	56.0	46.0	31.4	47.4	N	
6	6.39450	1.5	-18.1	13.1	14.6	-5.0	60.0	50.0	45.4	55.0	N	
7	0.22150	26.6	-2.9	12.6	39.2	9.7	62.7	52.7	23.5	43.0	L1	
8	0.30970	25.4	-4.9	12.7	38.1	7.8	59.9	49.9	21.8	42.1	L1	
9	0.40214	23.9	-6.4	12.7	36.6	6.3	57.8	47.8	21.2	41.5	L1	
10	0.50104	22.1	-7.7	12.7	34.8	5.0	56.0	46.0	21.2	41.0	L1	
11	1.58786	14.2	-12.9	12.8	27.0	-0.1	56.0	46.0	29.0	46.1	L1	
12	6.39494	-0.1	-18.5	13.1	13.0	-5.4	60.0	50.0	47.0	55.4	L1	

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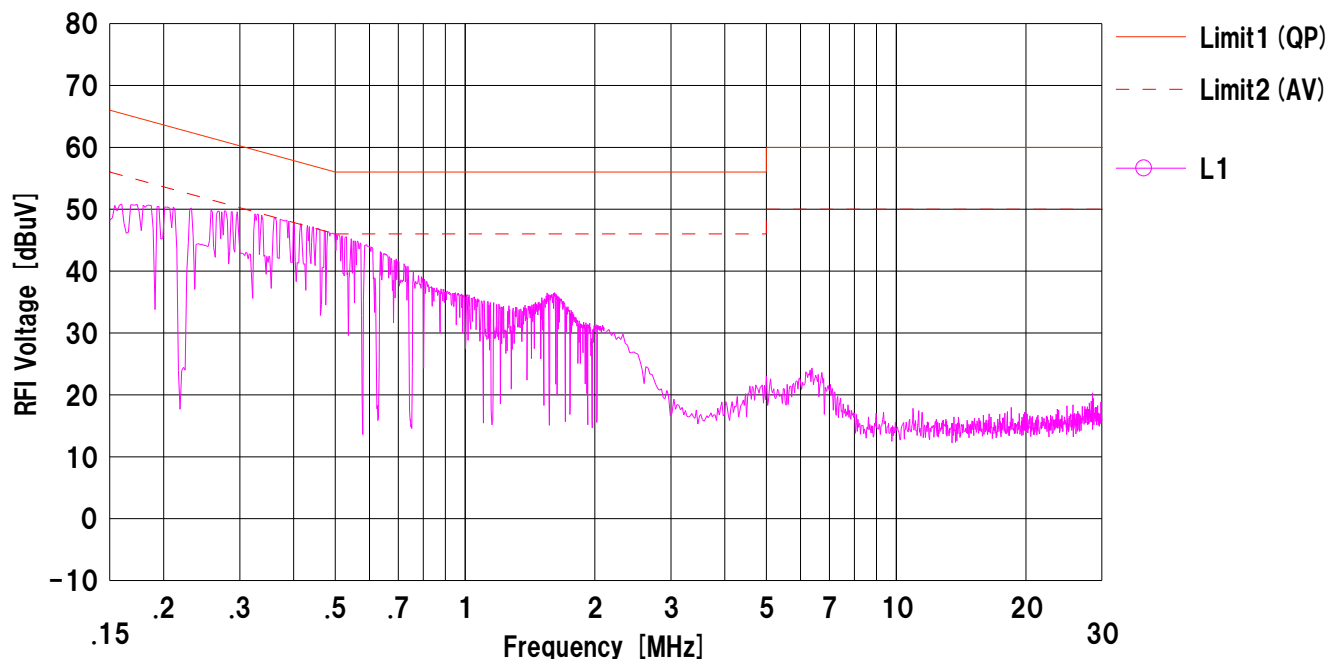
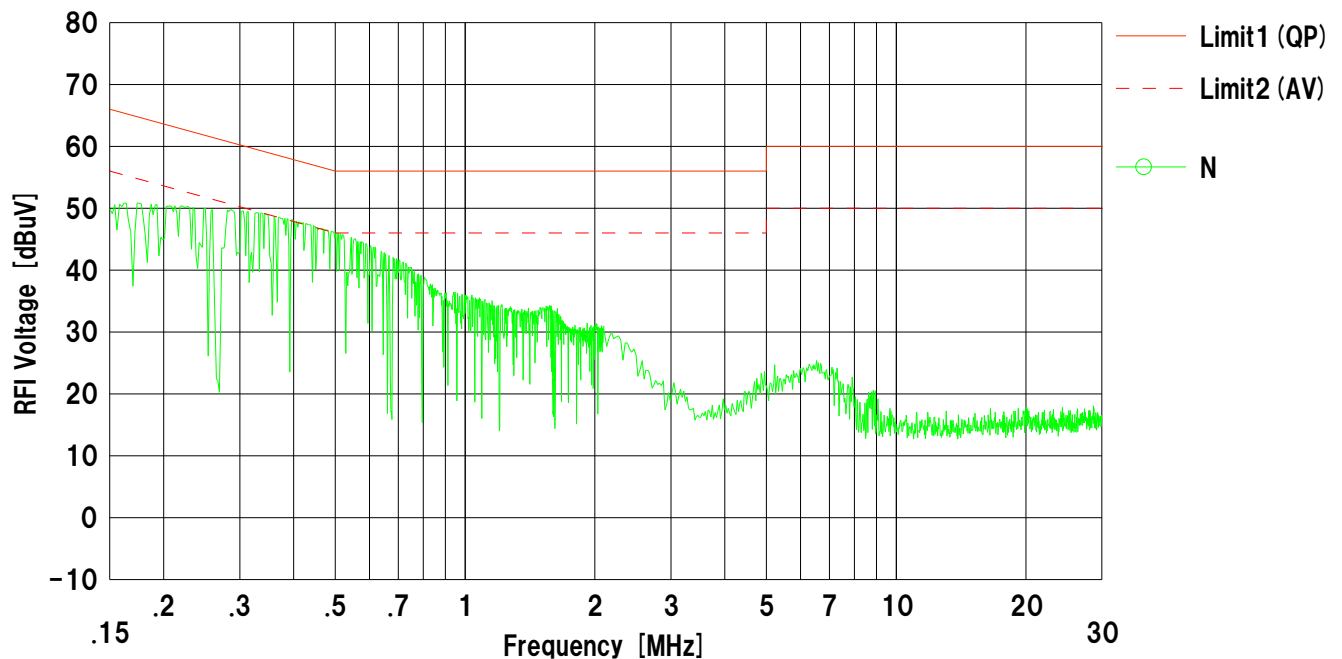
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT20) 5240MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
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Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



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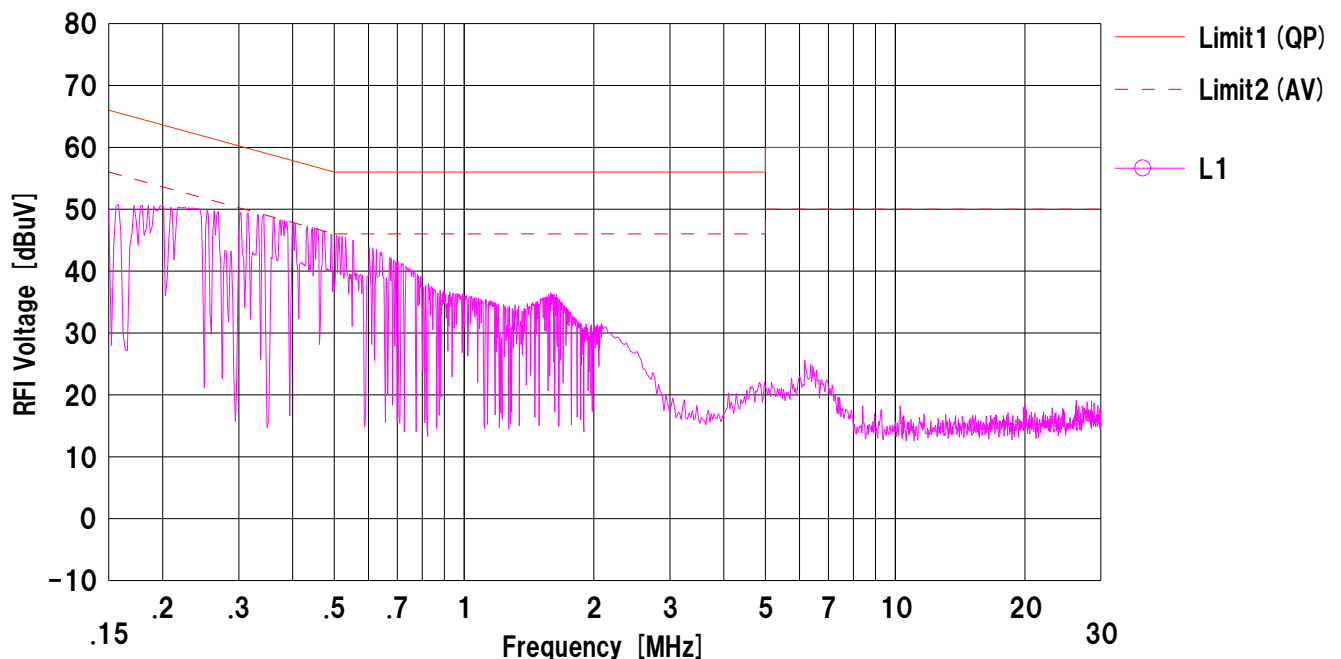
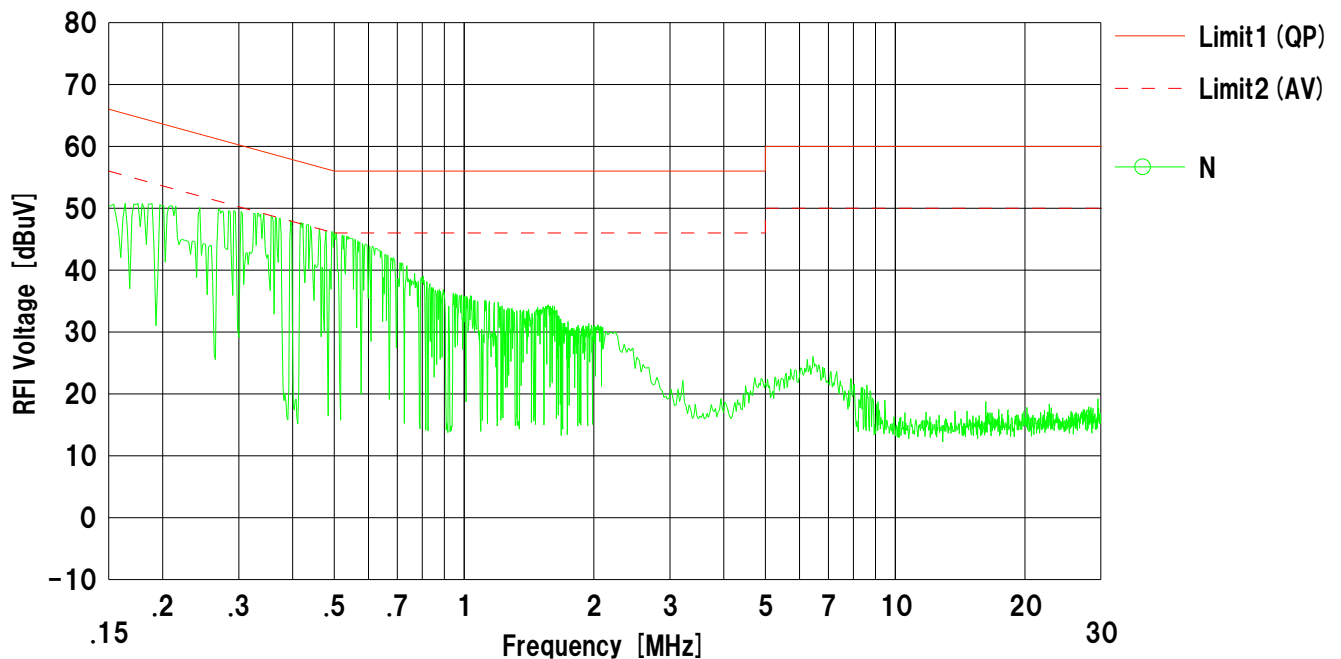
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT20) 5260MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



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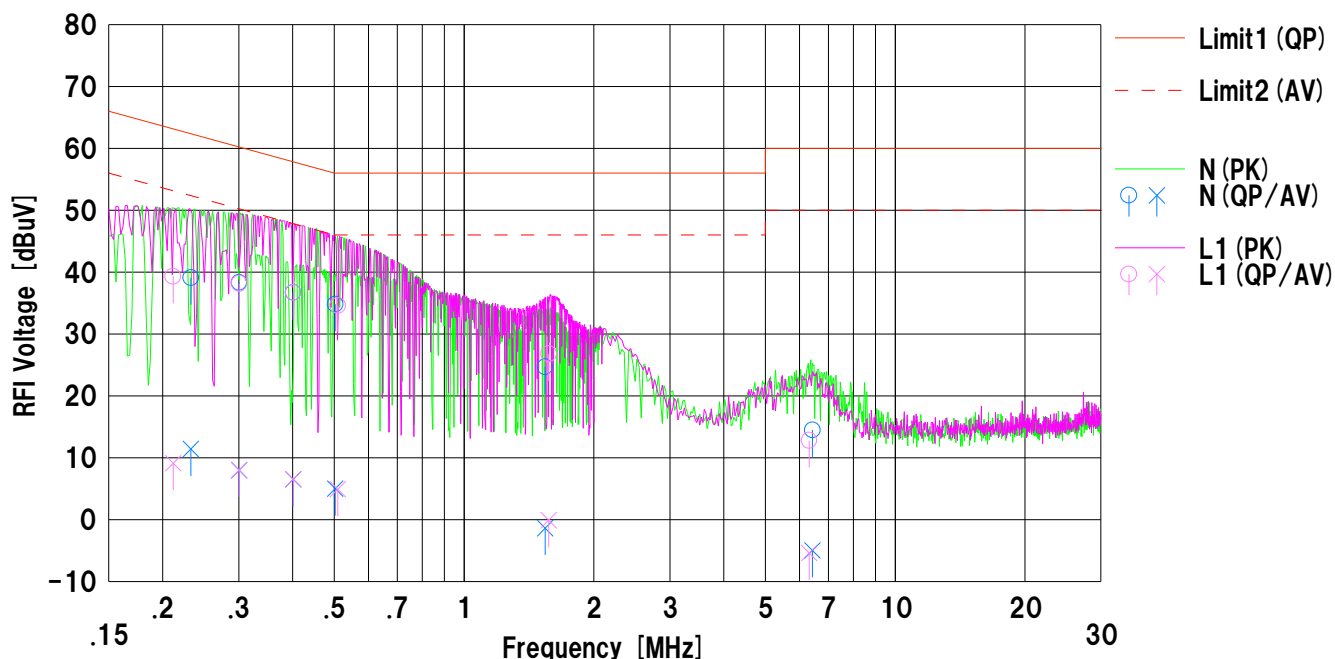
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT20) 5280MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



No.	Freq. [MHz]	Reading		C.Fac [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.23231	26.5	-1.2	12.6	39.1	11.4	62.3	52.3	23.2	40.9	N	
2	0.30063	25.6	-4.7	12.7	38.3	8.0	60.2	50.2	21.9	42.2	N	
3	0.40142	24.0	-6.2	12.7	36.7	6.5	57.8	47.8	21.1	41.3	N	
4	0.50243	22.1	-7.7	12.7	34.8	5.0	56.0	46.0	21.2	41.0	N	
5	1.54040	11.9	-14.2	12.8	24.7	-1.4	56.0	46.0	31.3	47.4	N	
6	6.42800	1.4	-18.1	13.1	14.5	-5.0	60.0	50.0	45.5	55.0	N	
7	0.21132	26.7	-3.5	12.6	39.3	9.1	63.1	53.1	23.8	44.0	L1	
8	0.30070	25.5	-4.7	12.7	38.2	8.0	60.2	50.2	22.0	42.2	L1	
9	0.40181	24.0	-6.2	12.7	36.7	6.5	57.8	47.8	21.1	41.3	L1	
10	0.50932	21.9	-7.8	12.7	34.6	4.9	56.0	46.0	21.4	41.1	L1	
11	1.57170	14.0	-12.9	12.8	26.8	-0.1	56.0	46.0	29.2	46.1	L1	
12	6.31150	-0.3	-18.5	13.1	12.8	-5.4	60.0	50.0	47.2	55.4	L1	

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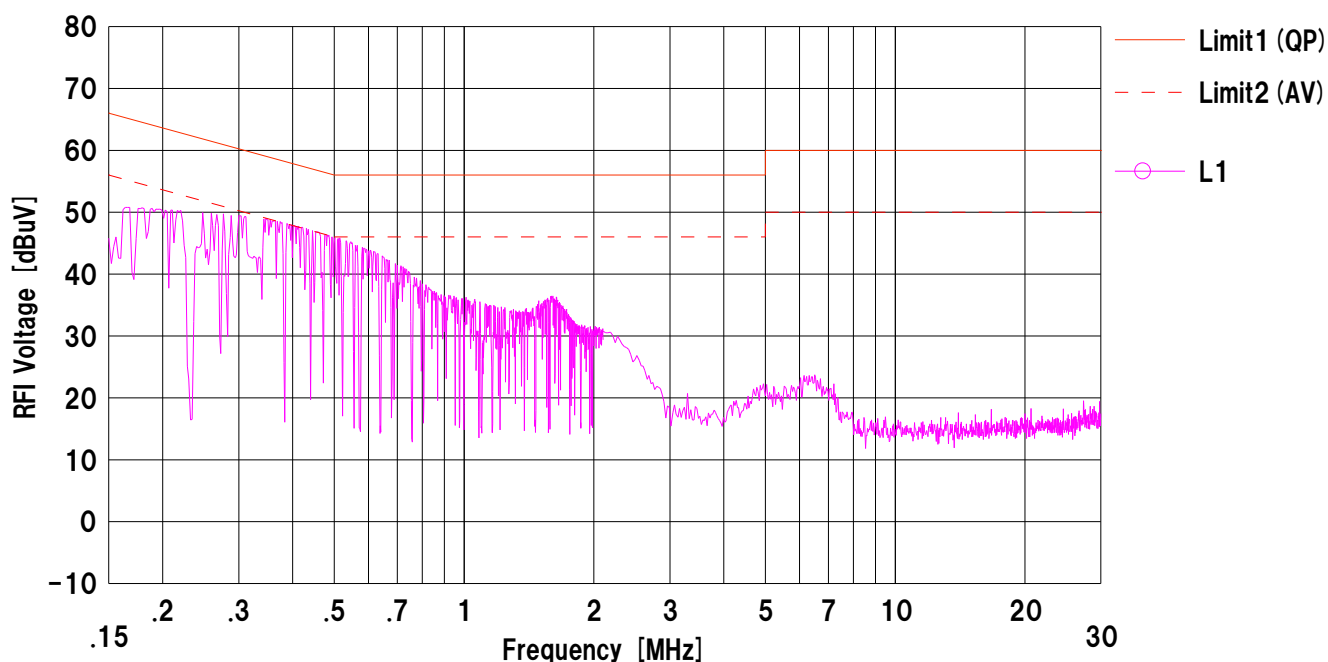
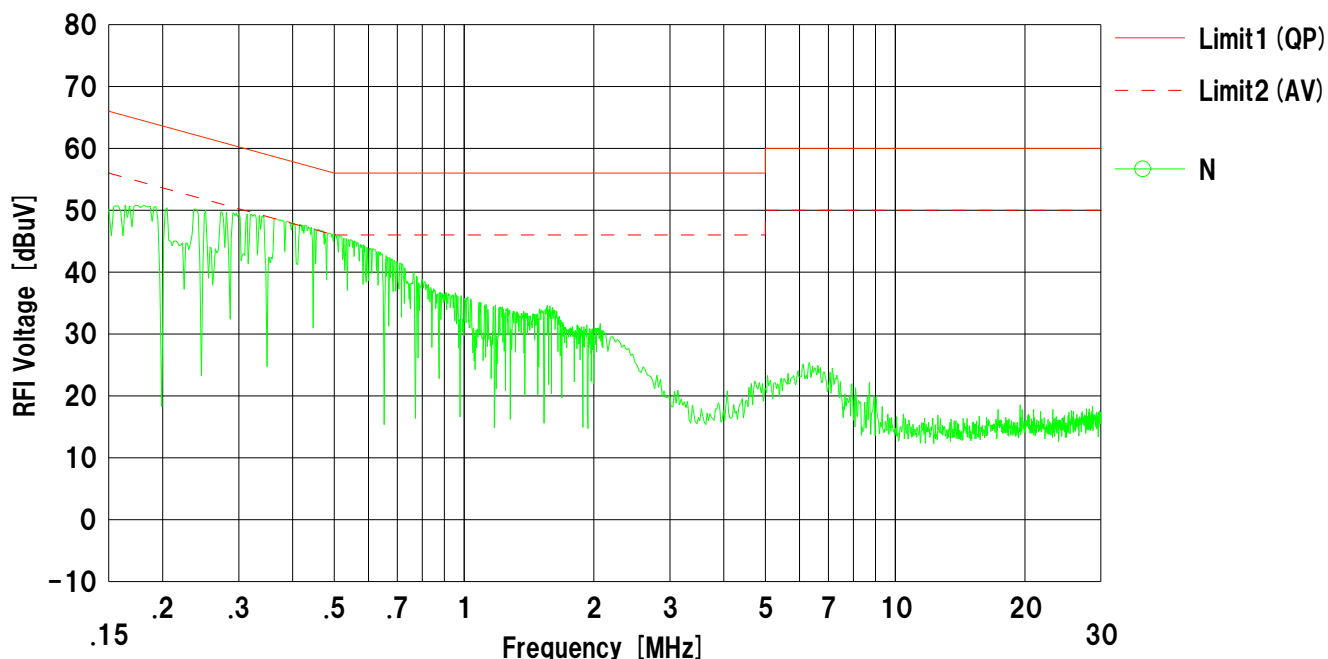
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT20) 5320MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



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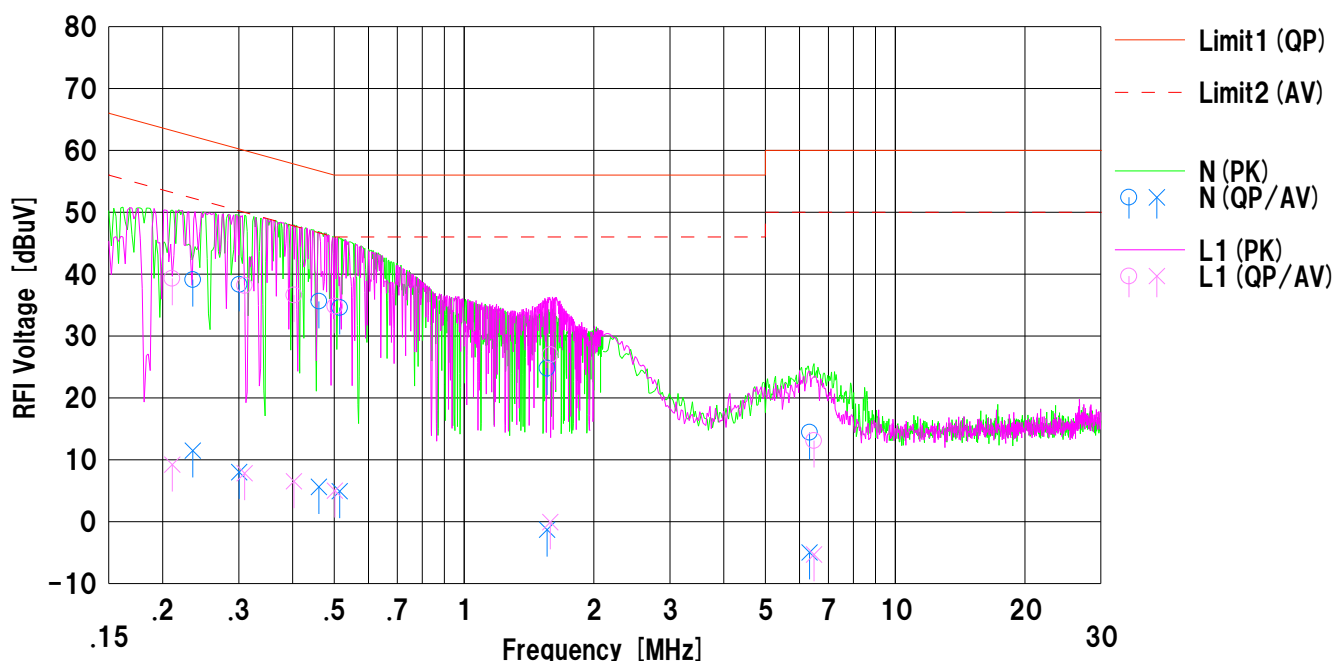
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT40) 5190MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



No.	Freq. [MHz]	Reading		C.Fac [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.23460	26.5	-1.1	12.6	39.1	11.5	62.2	52.2	23.1	40.7	N	
2	0.30100	25.6	-4.7	12.7	38.3	8.0	60.2	50.2	21.9	42.2	N	
3	0.46040	22.9	-7.1	12.7	35.6	5.6	56.6	46.6	21.0	41.0	N	
4	0.51462	21.9	-7.8	12.7	34.6	4.9	56.0	46.0	21.4	41.1	N	
5	1.55676	12.0	-14.1	12.8	24.8	-1.3	56.0	46.0	31.2	47.3	N	
6	6.32740	1.3	-18.1	13.1	14.4	-5.0	60.0	50.0	45.6	55.0	N	
7	0.21020	26.7	-3.4	12.6	39.3	9.2	63.1	53.1	23.8	43.9	L1	
8	0.30953	25.5	-4.9	12.7	38.2	7.8	59.9	49.9	21.7	42.1	L1	
9	0.40304	23.9	-6.2	12.7	36.6	6.5	57.7	47.7	21.1	41.2	L1	
10	0.50150	22.1	-7.7	12.7	34.8	5.0	56.0	46.0	21.2	41.0	L1	
11	1.58554	14.2	-12.9	12.8	27.0	-0.1	56.0	46.0	29.0	46.1	L1	
12	6.47830	0.0	-18.4	13.1	13.1	-5.3	60.0	50.0	46.9	55.3	L1	

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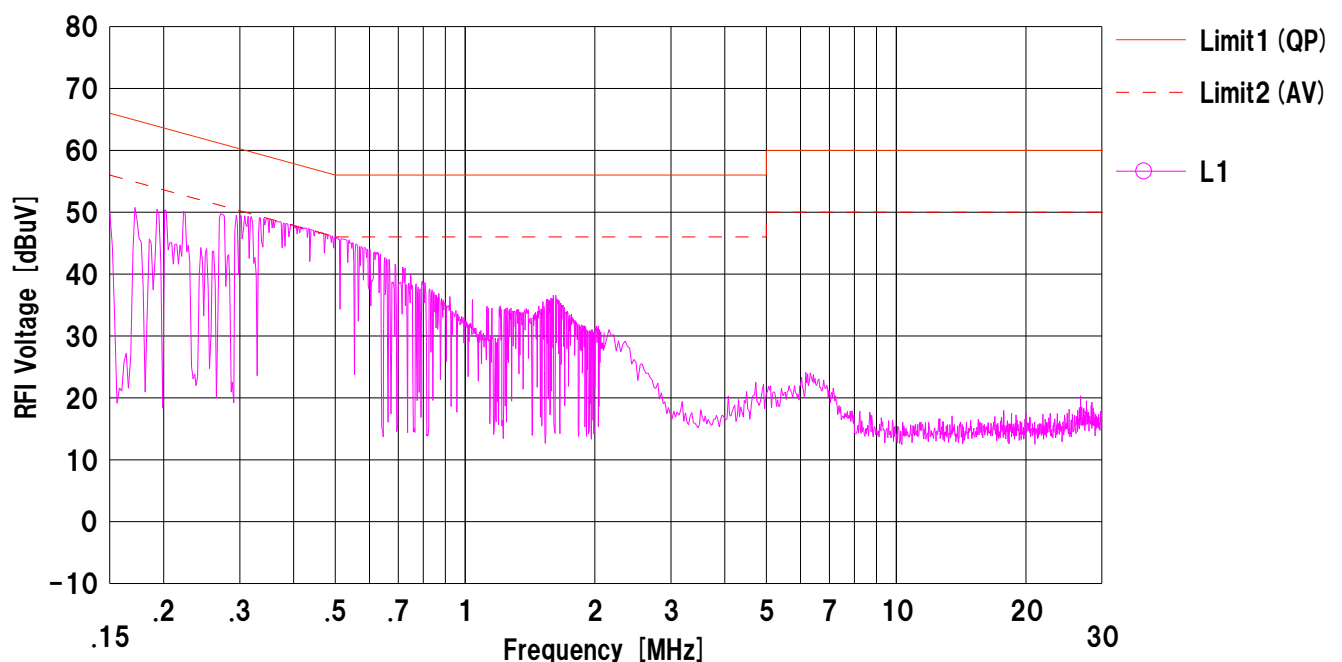
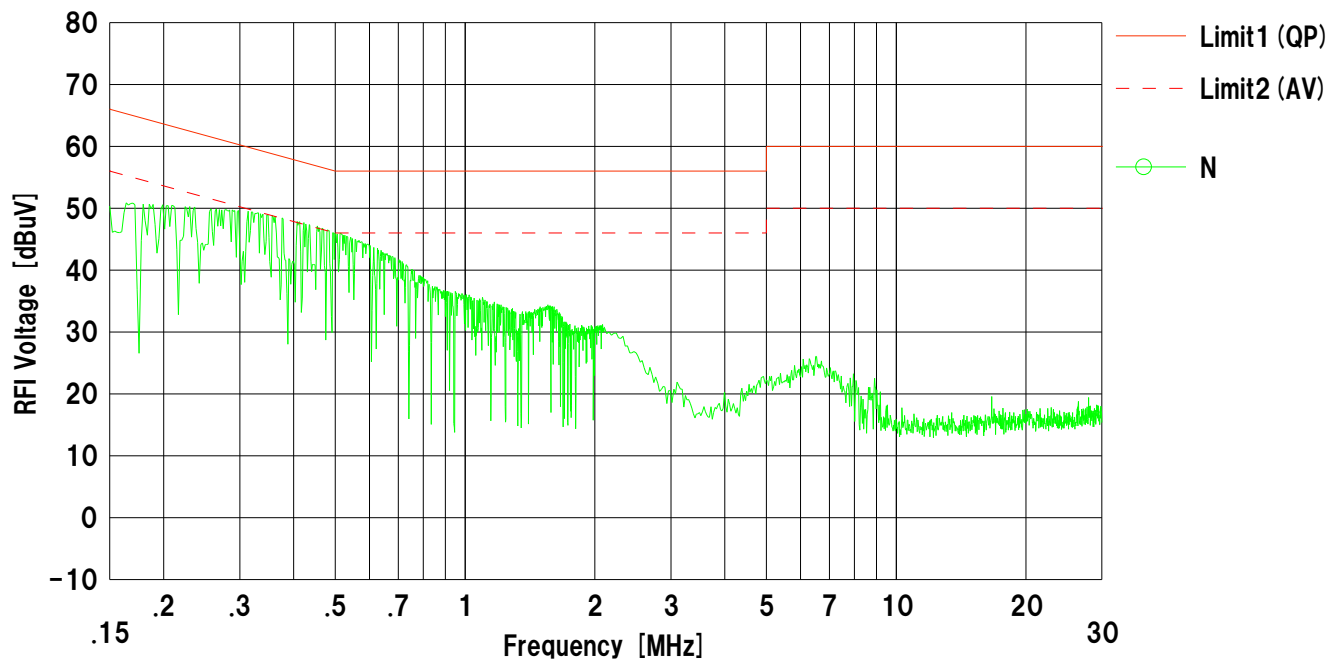
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT40) 5230MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



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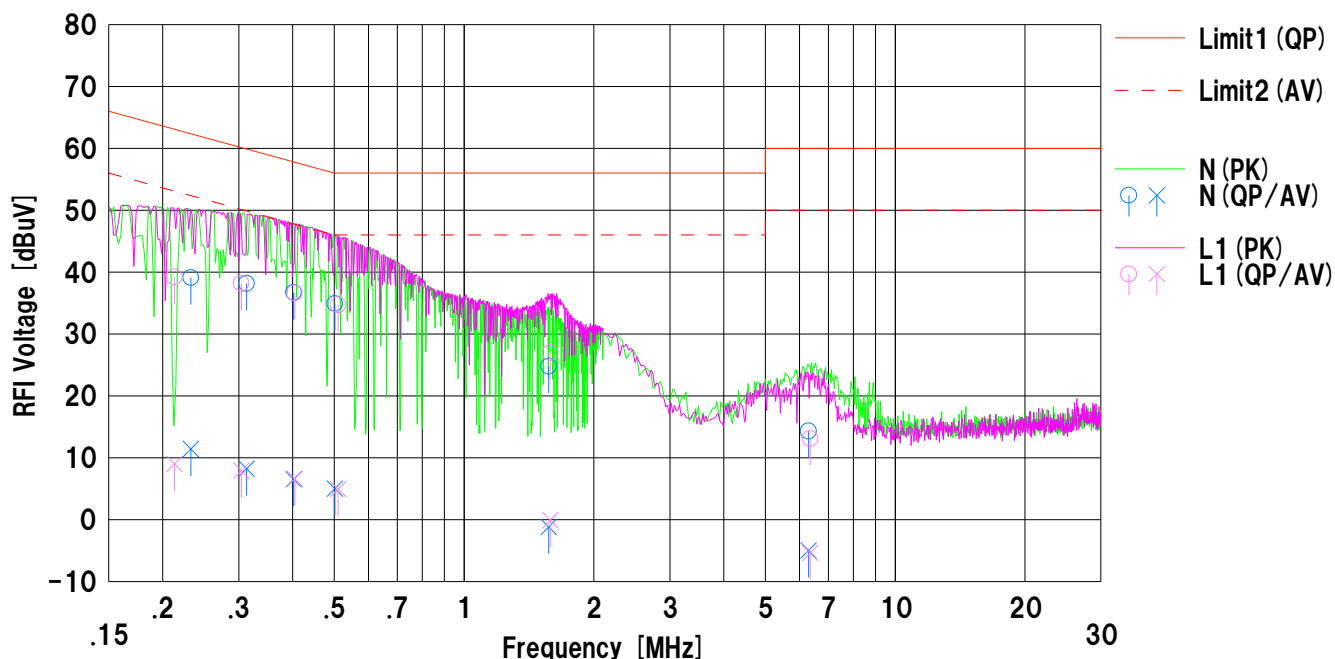
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

Mode : Tx 11n (HT40) 5270MHz
Report No. : 31CE0052-HO-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Akio Hayashi



No.	Freq. [MHz]	Reading		C.Fac [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.23240	26.5	-1.2	12.6	39.1	11.4	62.3	52.3	23.2	40.9	N	
2	0.31284	25.5	-4.5	12.7	38.2	8.2	59.8	49.8	21.6	41.6	N	
3	0.40235	24.0	-6.2	12.7	36.7	6.5	57.8	47.8	21.1	41.3	N	
4	0.50130	22.2	-7.7	12.7	34.9	5.0	56.0	46.0	21.1	41.0	N	
5	1.57050	12.0	-14.0	12.8	24.8	-1.2	56.0	46.0	31.2	47.2	N	
6	6.29400	1.2	-18.1	13.1	14.3	-5.0	60.0	50.0	45.7	55.0	N	
7	0.21283	26.6	-3.6	12.6	39.2	9.0	63.0	53.0	23.8	44.0	L1	
8	0.30419	25.5	-4.8	12.7	38.2	7.9	60.1	50.1	21.9	42.2	L1	
9	0.40460	23.9	-6.1	12.7	36.6	6.6	57.7	47.7	21.1	41.1	L1	
10	0.51055	22.0	-7.8	12.7	34.7	4.9	56.0	46.0	21.3	41.1	L1	
11	1.58550	14.2	-12.9	12.8	27.0	-0.1	56.0	46.0	29.0	46.1	L1	
12	6.35565	0.0	-18.5	13.1	13.1	-5.4	60.0	50.0	46.9	55.4	L1	

DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.2 Shielded Room
Date : 2011/06/25

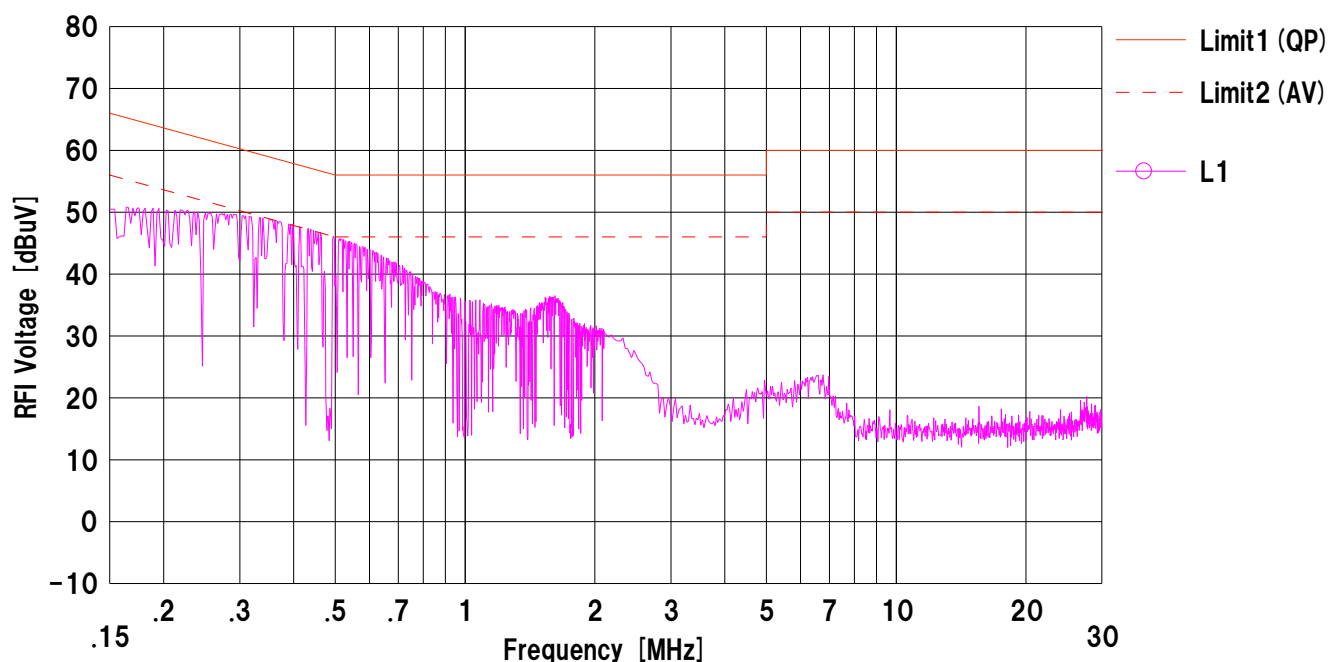
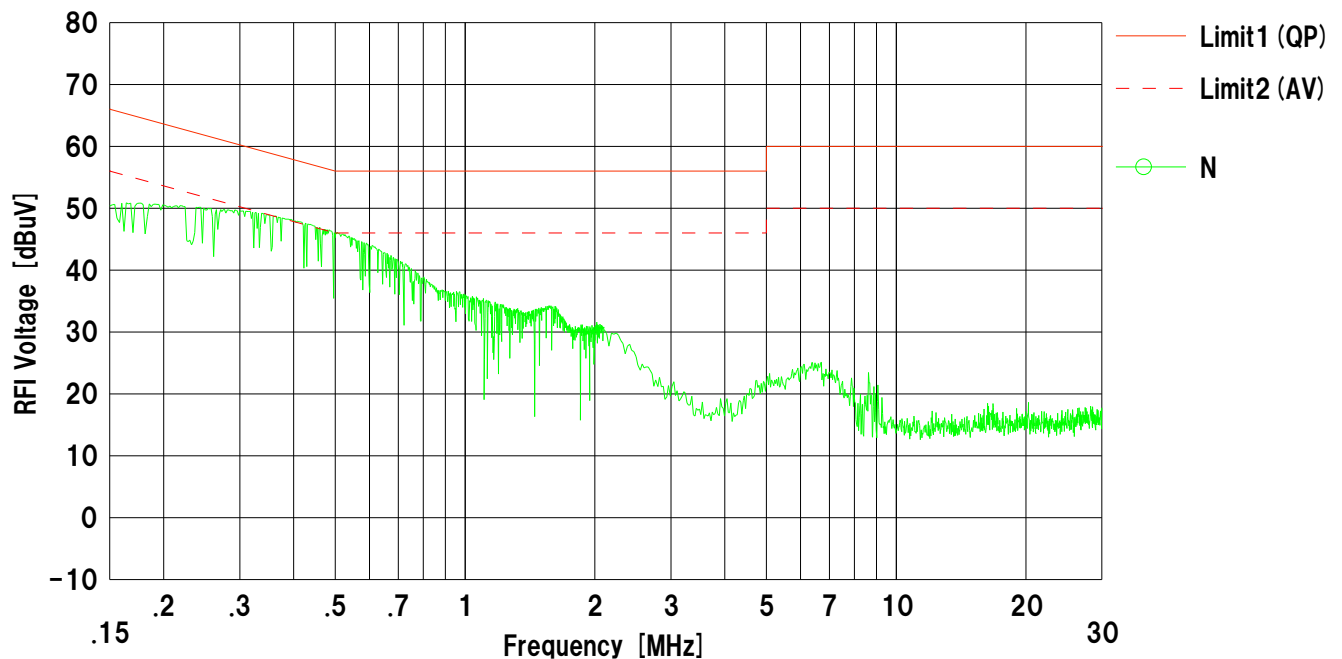
Company : CANON INC.
Kind of EUT : Wireless Module
Model No. : CH9-1225
Serial No. : ES4101

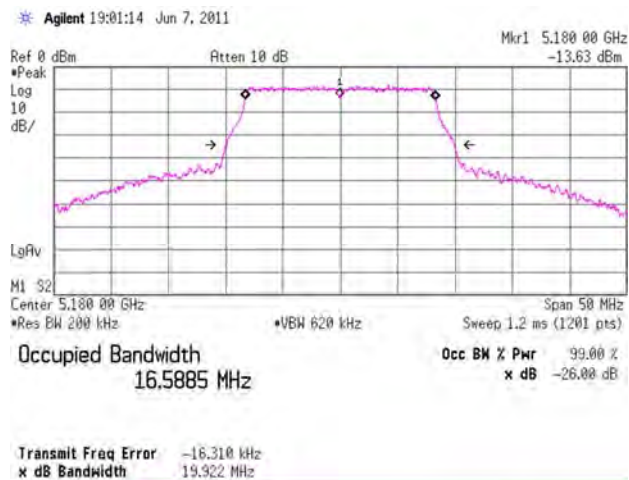
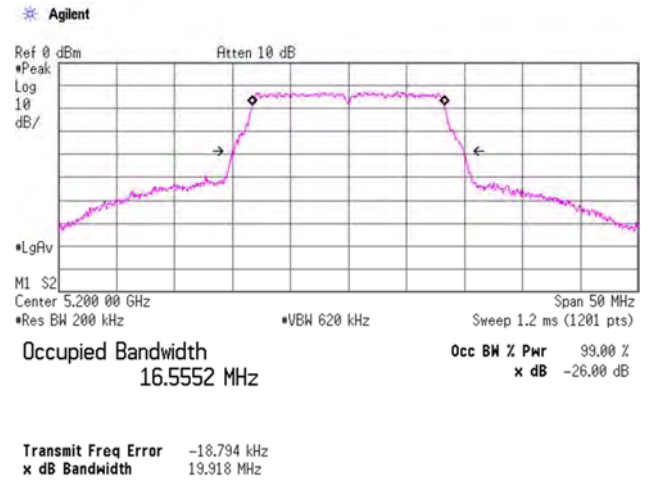
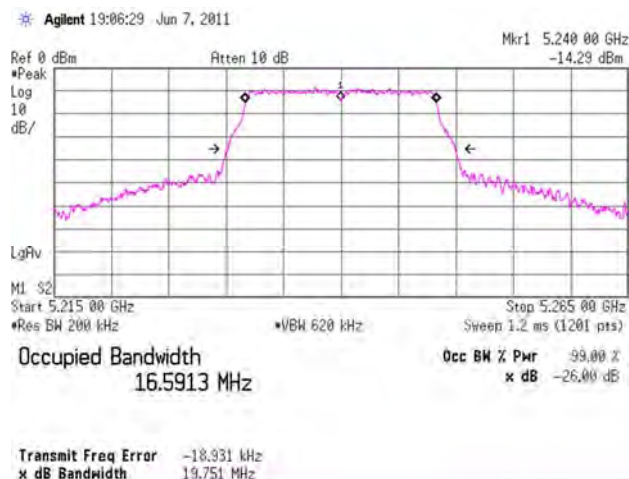
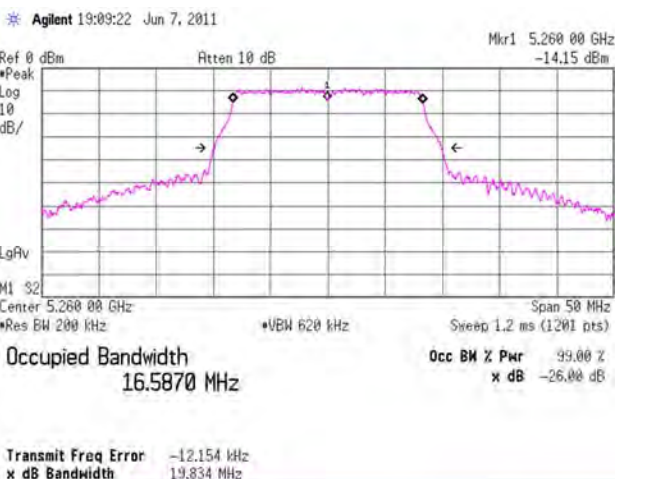
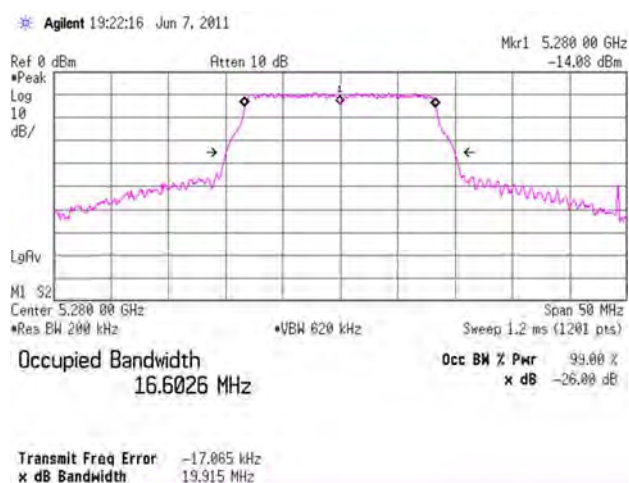
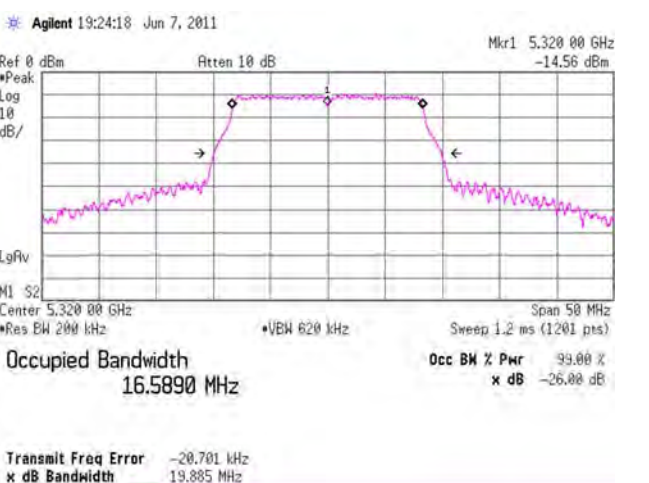
Mode : Tx 11n (HT40) 5310MHz
Report No. : 31CE0052-H0-01-K
Power : DC3.3V (AC120V/60Hz)
Temp./Humi. : 27deg.C. / 56%RH

Remarks : -

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

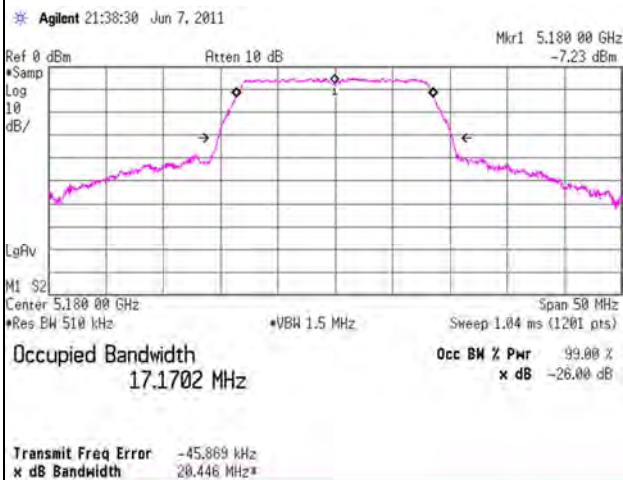
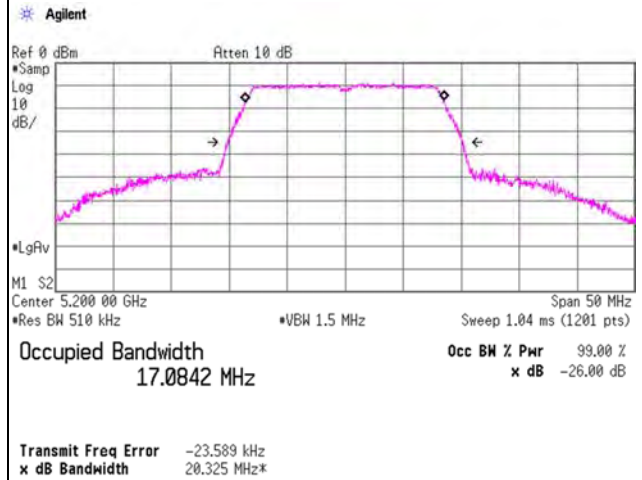
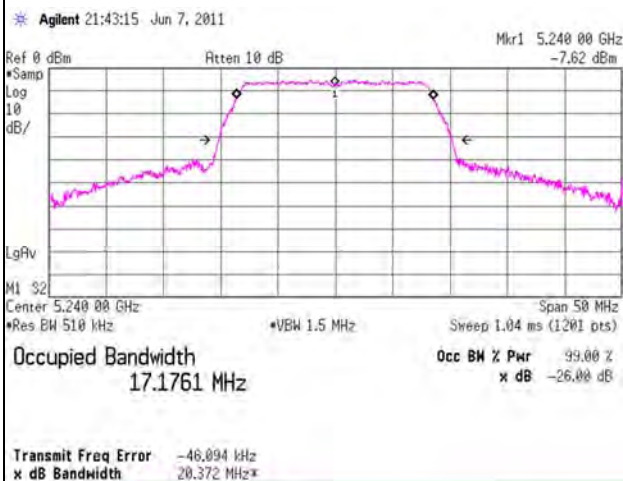
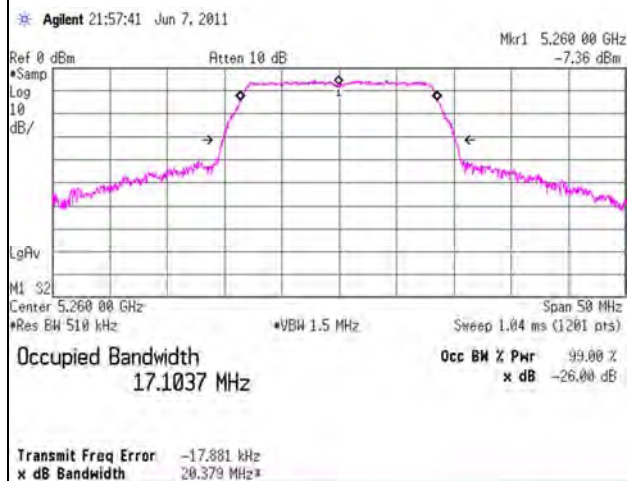
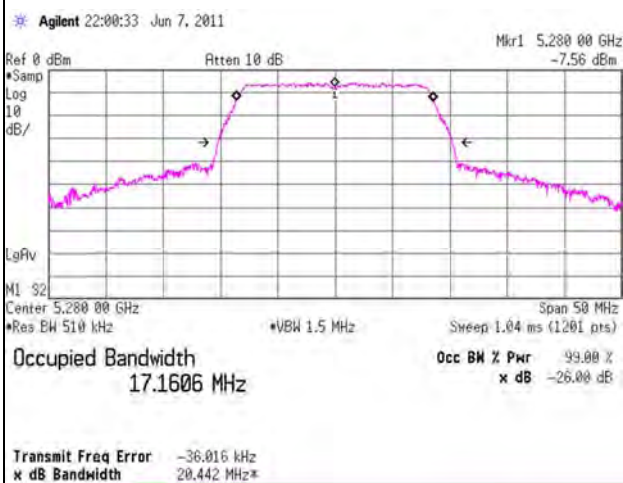
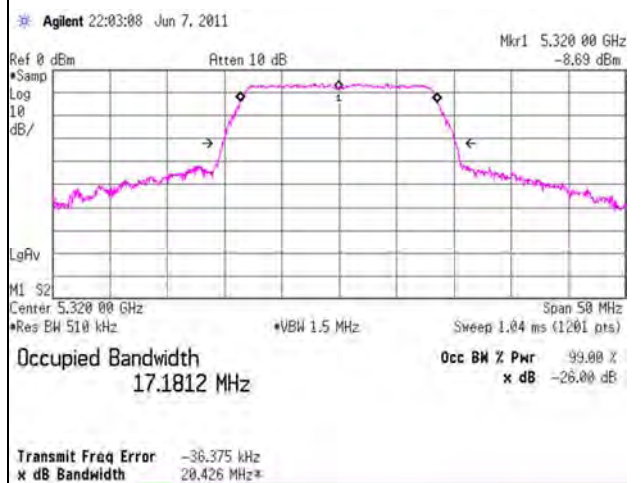
Engineer : Akio Hayashi



26dB Bandwidth**11a****Tx, 5180MHz****Tx, 5200MHz****Tx, 5240MHz****Tx, 5260MHz****Tx, 5280MHz****Tx, 5320MHz**

UL Japan, Inc.
Shonan EMC Lab.

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Facsimile : +81 463 50 6401

99% Occupied Bandwidth**11a****Tx, 5180MHz****Tx, 5200MHz****Tx, 5240MHz****Tx, 5260MHz****Tx, 5280MHz****Tx, 5320MHz**

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26dB Bandwidth and 99% Occupied Bandwidth

Test place	UL Japan, Inc. Shonan EMC Lab.	No.6 Shielded Room
Date	2011/6/9	
Temperature / Humidity	26deg.C.	62%RH
Engineer	Makoto Hosaka	
Mode	11n (HT20), Tx, Worst rate: MCS2	

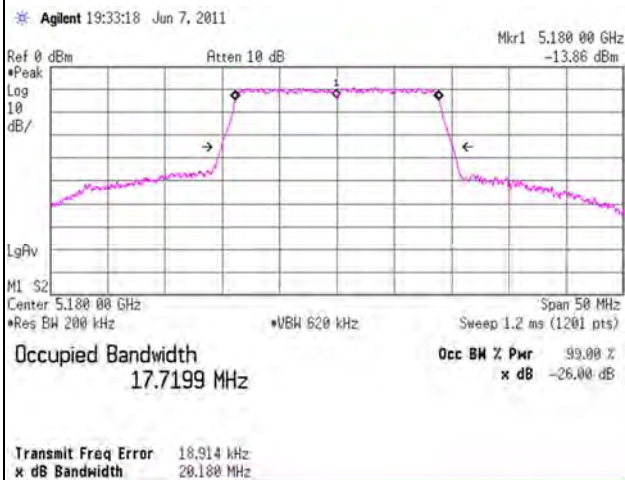
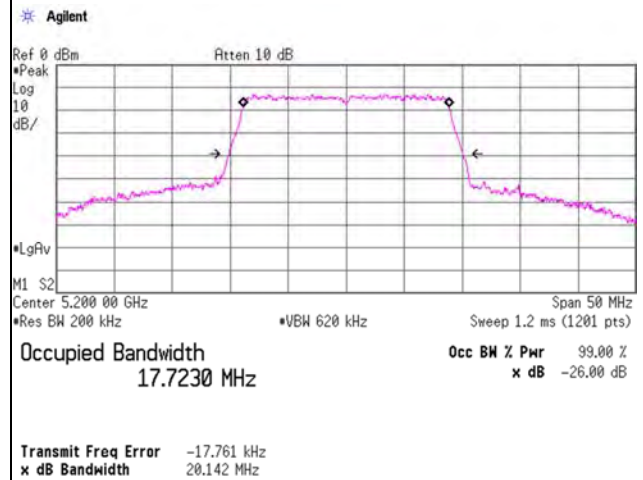
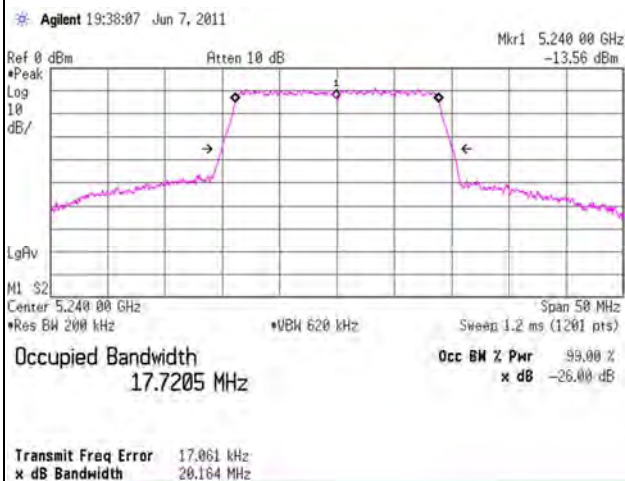
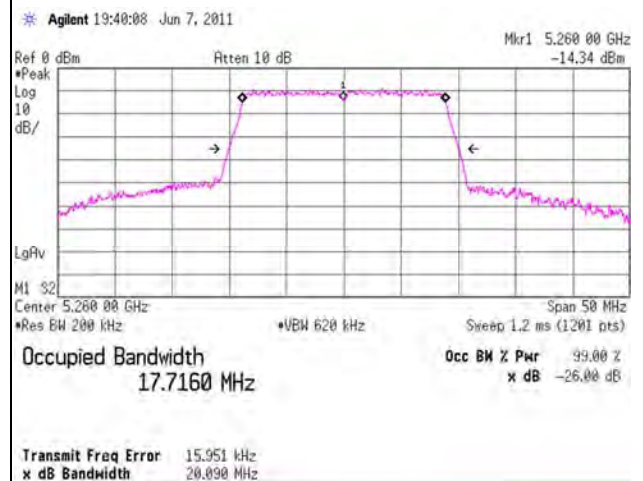
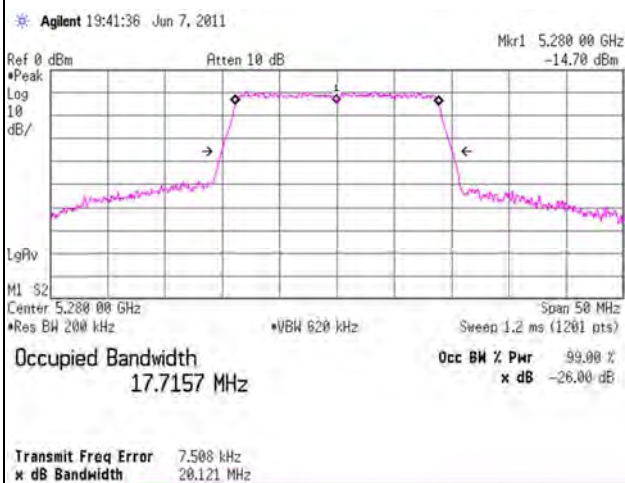
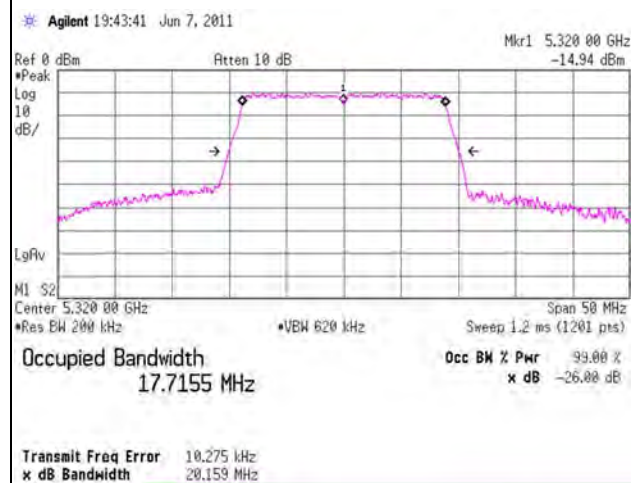
Frequency [MHz]	26dB Bandwidth [MHz]	99% Occupied Bandwidth [MHz]
5180	20.180	18.061
5200	20.142	18.054
5240	20.164	18.059
5260	20.090	18.083
5280	20.121	18.075
5320	20.159	18.058

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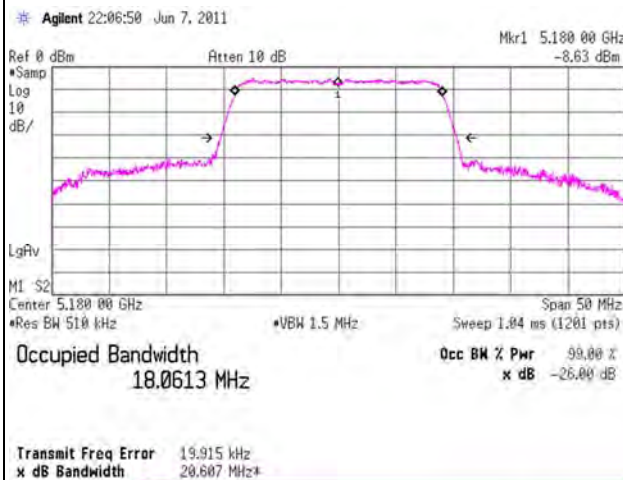
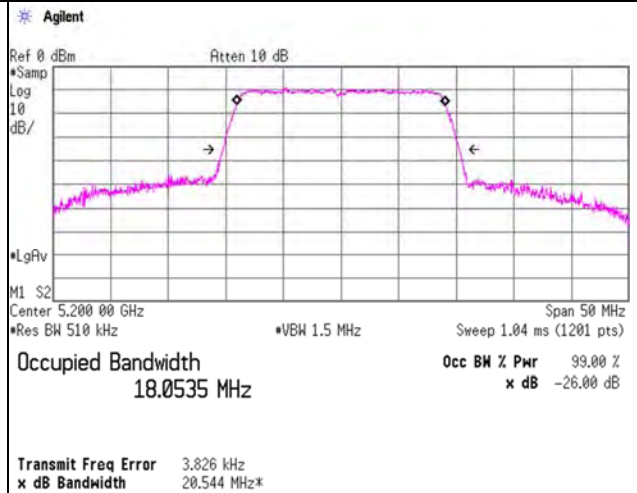
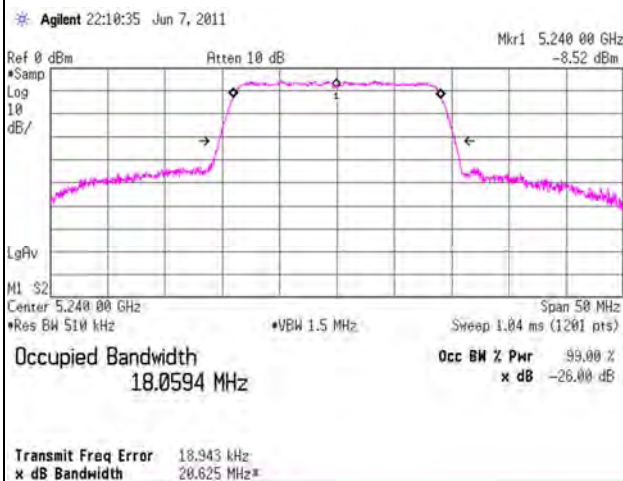
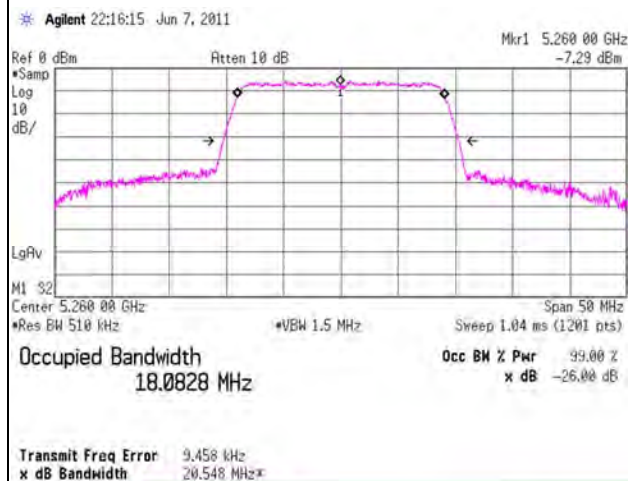
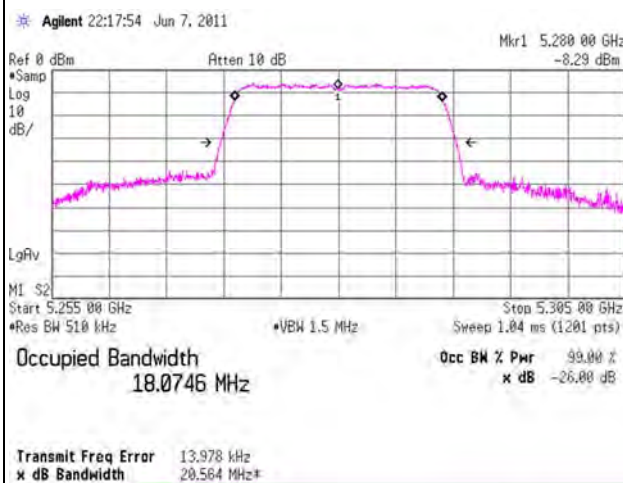
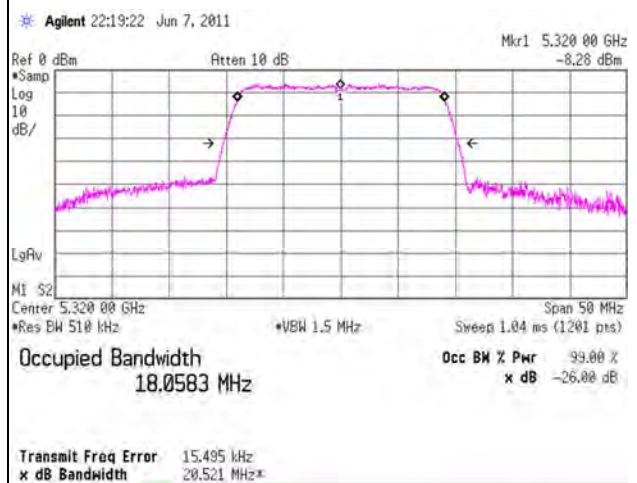
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

26dB Bandwidth**11n (HT20)****Tx, 5180MHz****Tx, 5200MHz****Tx, 5240MHz****Tx, 5260MHz****Tx, 5280MHz****Tx, 5320MHz**

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99% Occupied Bandwidth**11n (HT20)****Tx, 5180MHz****Tx, 5200MHz****Tx, 5240MHz****Tx, 5260MHz****Tx, 5280MHz****Tx, 5320MHz**

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26dB Bandwidth and 99% Occupied Bandwidth

Test place	UL Japan, Inc. Shonan EMC Lab.	No.6 Shielded Room
Date	2011/6/9	
Temperature / Humidity	26deg.C.	62%RH
Engineer	Makoto Hosaka	
Mode	11n (HT40), Tx, Worst rate: MCS2	

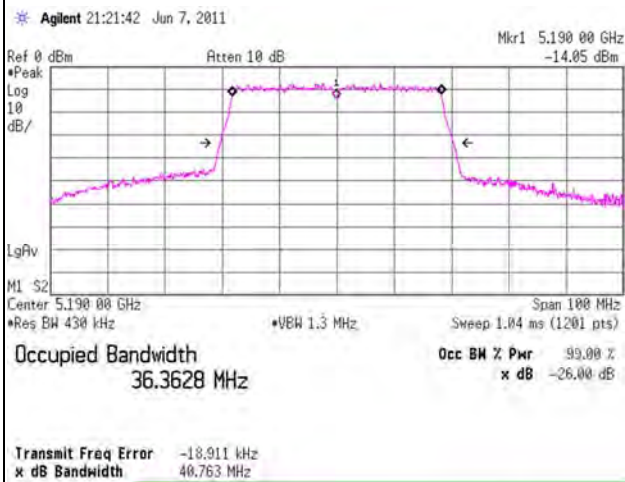
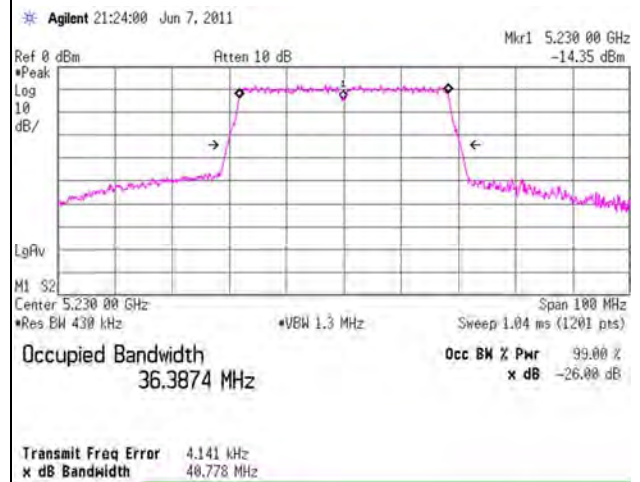
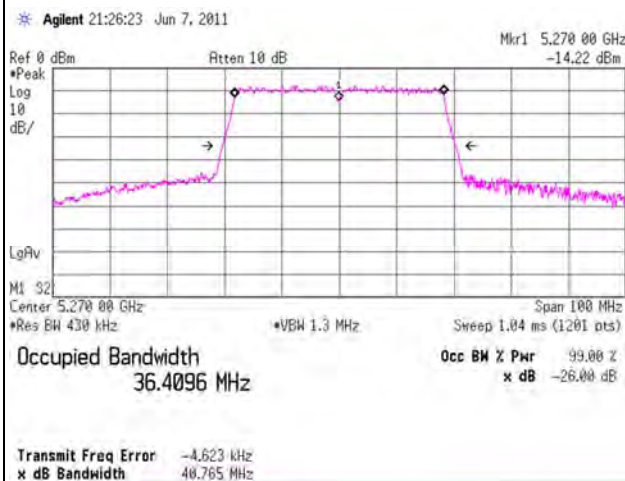
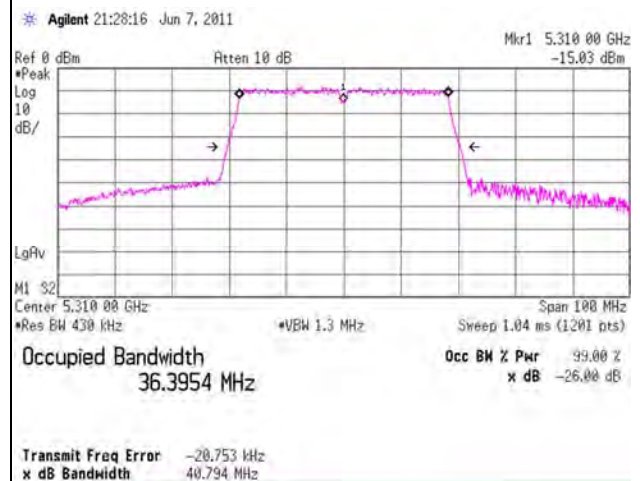
Frequency [MHz]	26dB Bandwidth [MHz]	99% Occupied Bandwidth [MHz]
5190	40.763	36.882
5230	40.778	36.854
5270	40.765	36.902
5310	40.794	36.827

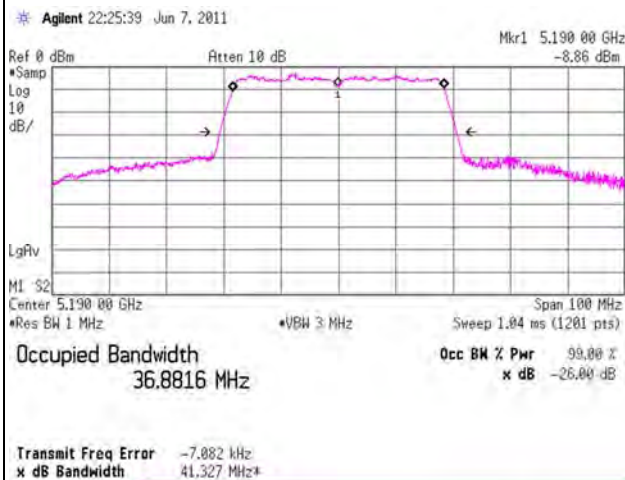
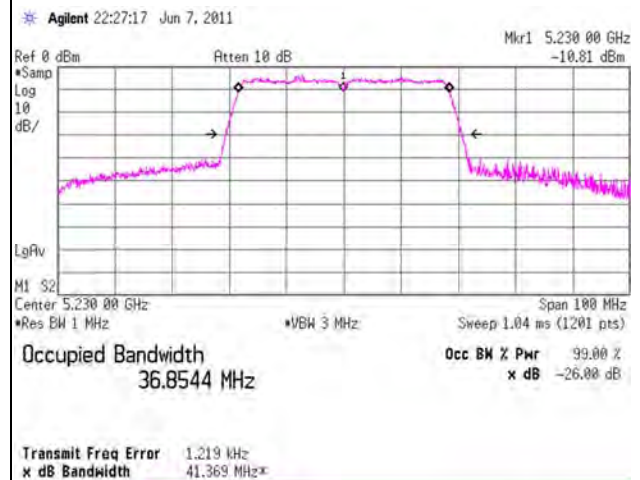
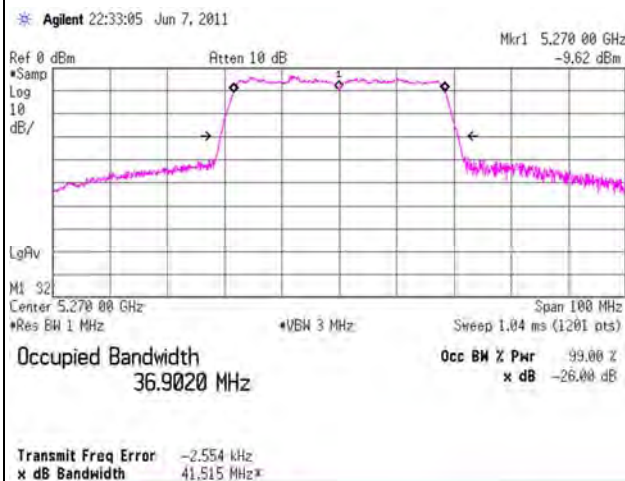
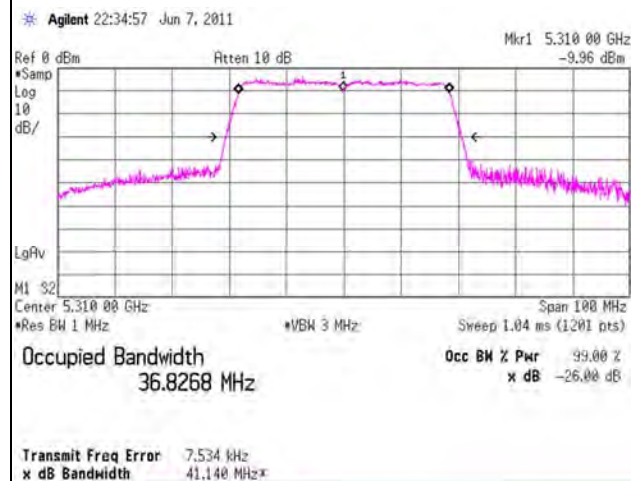
UL Japan, Inc.**Shonan EMC Lab.**

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26dB Bandwidth**11n (HT40)****Tx, 5190MHz****Tx, 5230MHz****Tx, 5270MHz****Tx, 5310MHz**

99% Occupied Bandwidth**11n (HT40)****Tx, 5190MHz****Tx, 5230MHz****Tx, 5270MHz****Tx, 5310MHz**

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Peak Output Power (Conducted)

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 2011/5/19
 Temperature / Humidity 24deg.C. 49%RH
 Engineer Tatsuya Arai
 Mode 11a, Tx, Worst rate: 6Mbps

Ch	Freq. [MHz]	S/A (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low band, Low	5180.0	2.84	0.90	9.64	13.38	21.78	16.99	50.00	3.61
Low band, Mid	5200.0	2.84	0.90	9.63	13.37	21.73	16.99	50.00	3.62
Low band, High	5240.0	2.71	0.90	9.62	13.23	21.04	16.96	49.61	3.73
Mid band, Low	5260.0	2.75	0.90	9.62	13.27	21.23	23.97	249.70	10.70
Mid band, Mid	5280.0	2.59	0.90	9.61	13.10	20.42	23.98	250.00	10.88
Mid band, High	5320.0	2.43	0.90	9.60	12.93	19.63	23.98	250.00	11.05

Sample Calculation:

Result = Reading + Cable Loss (supplied by customer) + Atten. Loss

* In the above table, factor 0.0dB represents no use of Atten. and/or Filter.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*Limit: Low band: 50mW(Low and Mid ch), 4dBm+10logB (B=26dB Bandwidth, High ch),

Mid band: 250mW (Mid and High ch), 11dBm+10logB (B=26dB Bandwidth, Low ch)

[Pre check]

Data Rate [Mbps]	Freq. [MHz]	S/A (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
6	5260.0	2.75	0.90	9.62	13.27	21.23	23.97	249.70	10.70
9	5260.0	2.60	0.90	9.62	13.12	20.51	23.97	249.70	10.85
12	5260.0	2.69	0.90	9.62	13.21	20.94	23.97	249.70	10.76
18	5260.0	2.67	0.90	9.62	13.19	20.84	23.97	249.70	10.78
24	5260.0	2.60	0.90	9.62	13.12	20.51	23.97	249.70	10.85
36	5260.0	2.69	0.90	9.62	13.21	20.94	23.97	249.70	10.76
48	5260.0	2.63	0.90	9.62	13.15	20.65	23.97	249.70	10.82
54	5260.0	2.63	0.90	9.62	13.15	20.65	23.97	249.70	10.82

Reference data for SAR testing

Data Rate [Mbps]	Freq. [MHz]	P/M (PK) Reading [dBm]	P/M (AV) Reading [dBm]	loss [dB]	Result	
					PK [dBm]	AV [dBm]
6	5260.0	12.32	2.93	10.52	22.84	13.45
9	5260.0	12.02	2.89	10.52	22.54	13.41
12	5260.0	12.20	2.90	10.52	22.72	13.42
18	5260.0	11.69	2.92	10.52	22.21	13.44
24	5260.0	12.45	2.89	10.52	22.97	13.41
36	5260.0	12.22	2.83	10.52	22.74	13.35
48	5260.0	11.98	2.85	10.52	22.50	13.37
54	5260.0	12.18	2.82	10.52	22.70	13.34

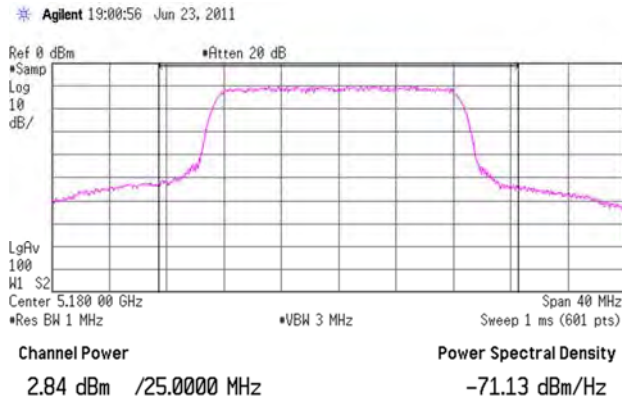
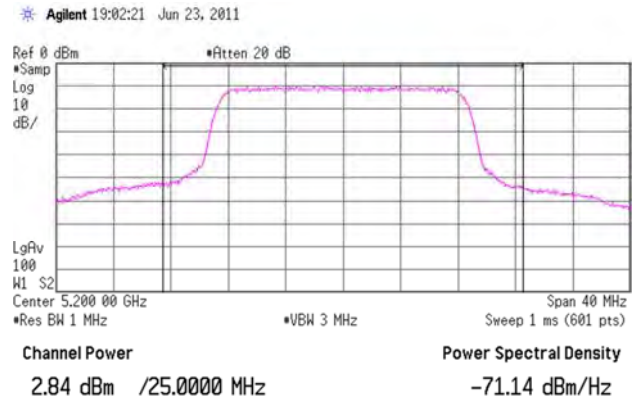
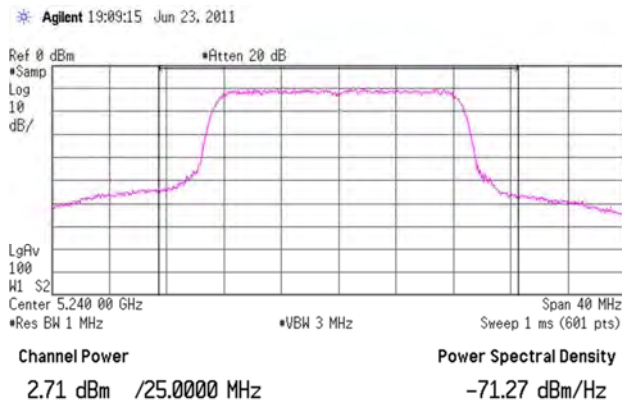
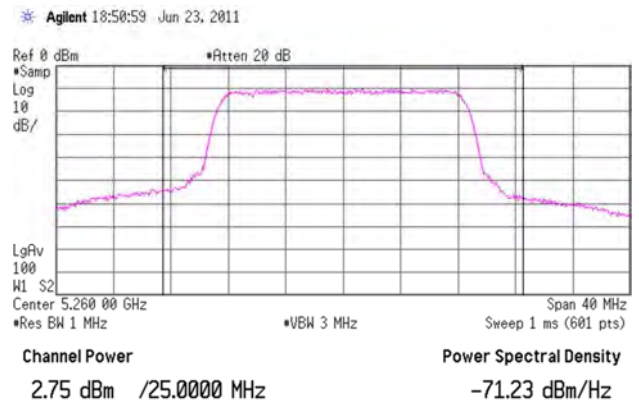
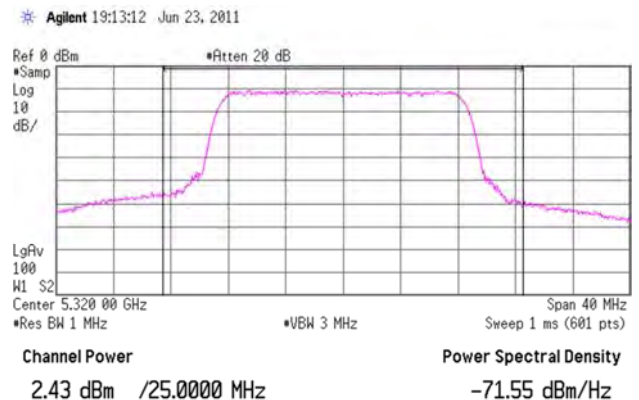
S/A: Spectrum analyzer
 P/M: Power meter with Power sensor

UL Japan, Inc.
Shonan EMC Lab.

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Telephone : +81 463 50 6400

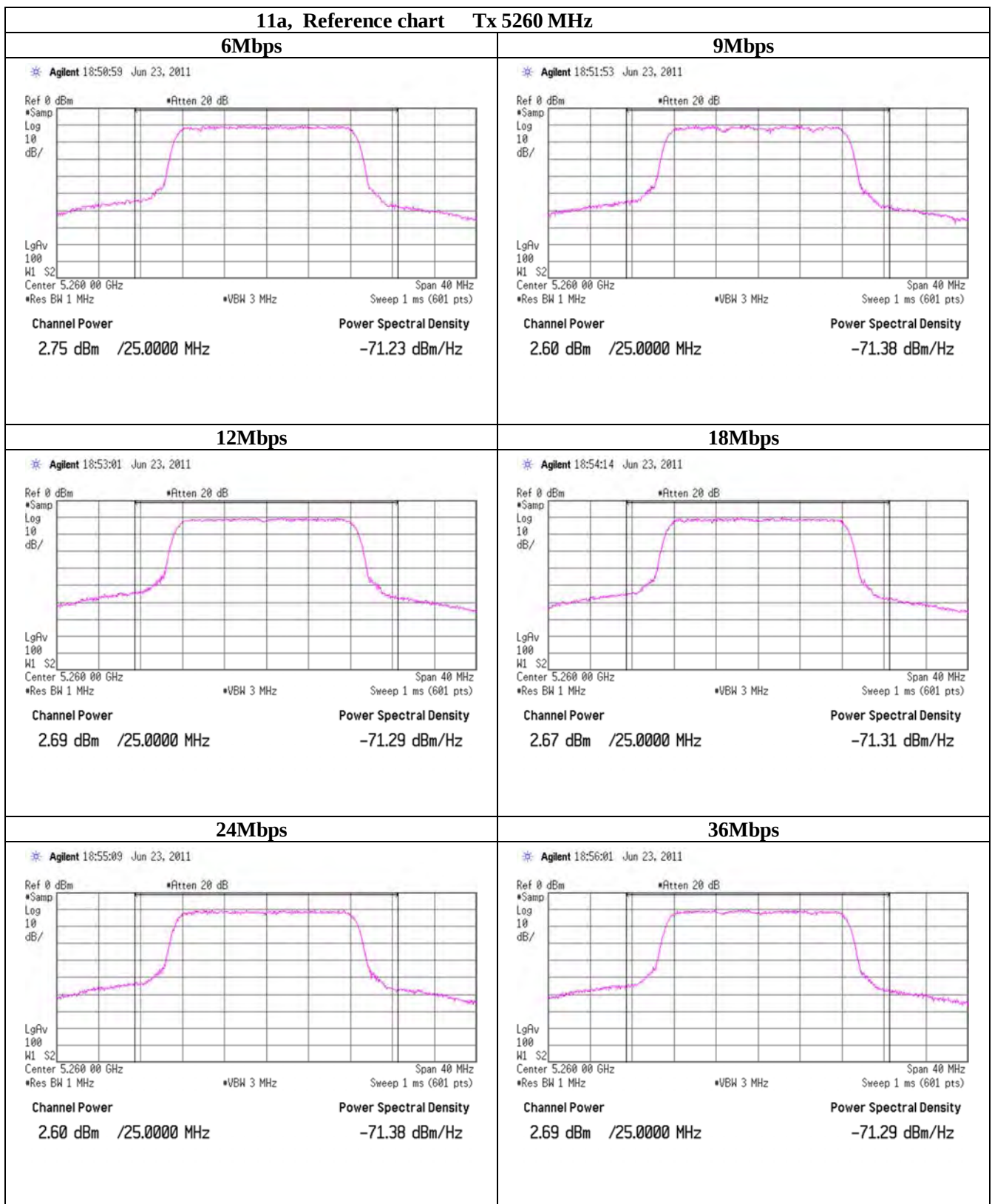
Facsimile : +81 463 50 6401

Peak Output Power (Conducted)**11a****Tx, 5180MHz****Tx, 5200MHz****Tx, 5240MHz****Tx, 5260MHz****Tx, 5280MHz****Tx, 5320MHz**

UL Japan, Inc.
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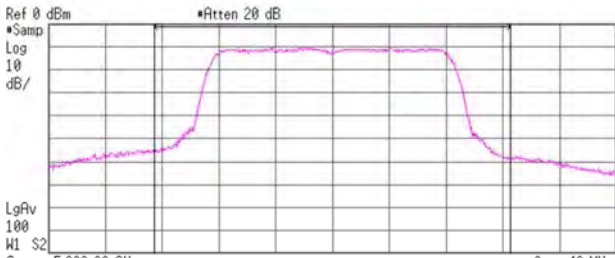
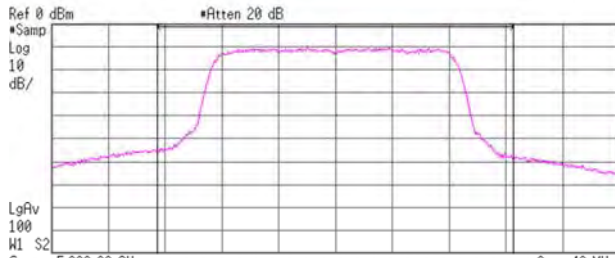
Peak Output Power (Conducted)



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Shonan EMC Lab.

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Facsimile : +81 463 50 6401

Peak Output Power (Conducted)

11a, Reference chart Tx 5260 MHz	
48Mbps	54Mbps
Agilent 18:56:40 Jun 23, 2011  Channel Power 2.63 dBm /25.0000 MHz Power Spectral Density -71.34 dBm/Hz	Agilent 18:57:18 Jun 23, 2011  Channel Power 2.63 dBm /25.0000 MHz Power Spectral Density -71.35 dBm/Hz

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Telephone : +81 463 50 6400
Facsimile : +81 463 50 6401

Peak Output Power (Conducted)

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 2011/5/19
 Temperature / Humidity 24deg.C. 49%RH
 Engineer Tatsuya Arai
 Mode 11n (HT20), Tx, Worst rate: MCS2

Ch	Freq. [MHz]	S/A (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low band, Low	5180.0	2.87	0.90	9.64	13.41	21.93	16.99	50.00	3.58
Low band, Mid	5200.0	2.80	0.90	9.63	13.33	21.53	16.99	50.00	3.66
Low band, High	5240.0	2.69	0.90	9.62	13.21	20.94	16.99	50.00	3.78
Mid band, Low	5260.0	2.74	0.90	9.62	13.26	21.18	23.98	250.00	10.72
Mid band, Mid	5280.0	2.60	0.90	9.61	13.11	20.46	23.98	250.00	10.87
Mid band, High	5320.0	2.41	0.90	9.60	12.91	19.54	23.98	250.00	11.07

Sample Calculation:

Result = Reading + Cable Loss (supplied by customer) + Atten. Loss

* In the above table, factor 0.0dB represents no use of Atten. and/or Filter.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*Limit: Low band: 50mW, Mid band: 250mW

[Pre check]

Data Rate [MCS]	Freq. [MHz]	S/A (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
0	5260.0	2.63	0.90	9.62	13.15	20.65	23.98	250.00	10.83
1	5260.0	2.68	0.90	9.62	13.20	20.89	23.98	250.00	10.78
2	5260.0	2.74	0.90	9.62	13.26	21.18	23.98	250.00	10.72
3	5260.0	2.63	0.90	9.62	13.15	20.65	23.98	250.00	10.83
4	5260.0	2.69	0.90	9.62	13.21	20.94	23.98	250.00	10.77
5	5260.0	2.65	0.90	9.62	13.17	20.75	23.98	250.00	10.81
6	5260.0	2.69	0.90	9.62	13.21	20.94	23.98	250.00	10.77
7	5260.0	2.69	0.90	9.62	13.21	20.94	23.98	250.00	10.77

Reference data for SAR testing

Data Rate [MCS]	Freq. [MHz]	P/M (PK) Reading [dBm]	P/M (AV) Reading [dBm]	loss [dB]	Result	
					PK [dBm]	AV [dBm]
0	5260.0	11.71	2.93	10.52	22.23	13.45
1	5260.0	11.66	2.92	10.52	22.18	13.44
2	5260.0	11.62	2.95	10.52	22.14	13.47
3	5260.0	11.72	2.92	10.52	22.24	13.44
4	5260.0	11.72	2.94	10.52	22.24	13.46
5	5260.0	11.60	2.93	10.52	22.12	13.45
6	5260.0	11.73	2.92	10.52	22.25	13.44
7	5260.0	11.75	2.91	10.52	22.27	13.43

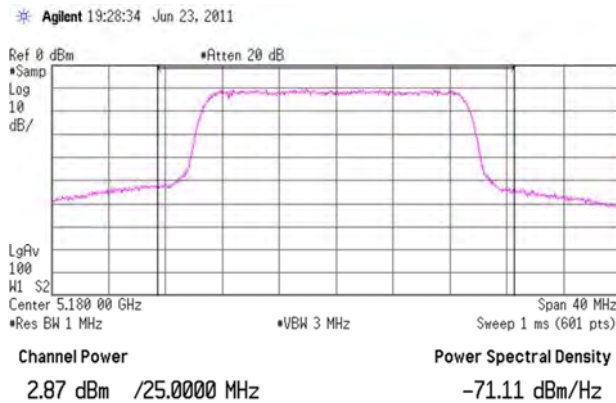
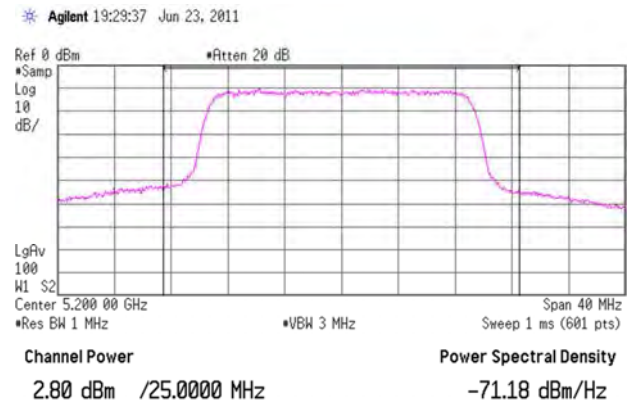
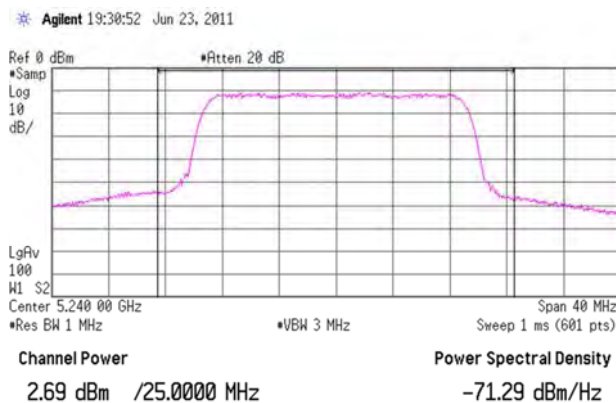
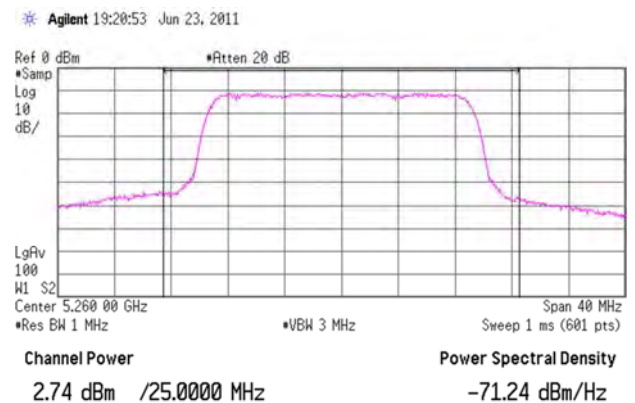
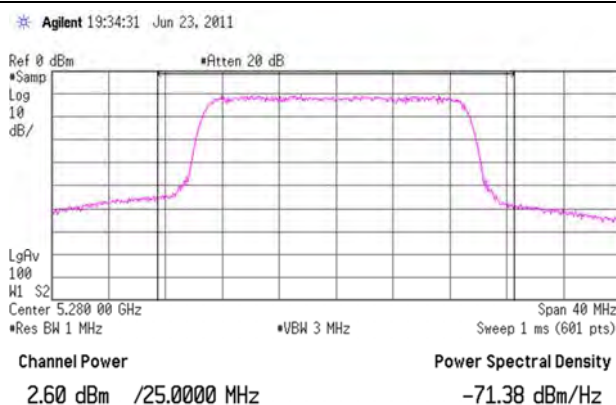
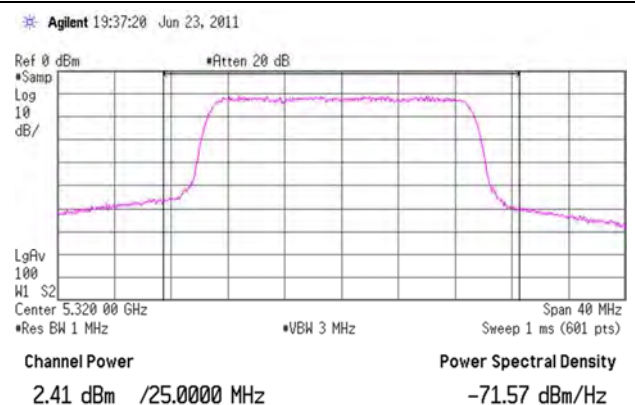
S/A: Spectrum analyzer
 P/M: Power meter with Power sensor

UL Japan, Inc.
Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

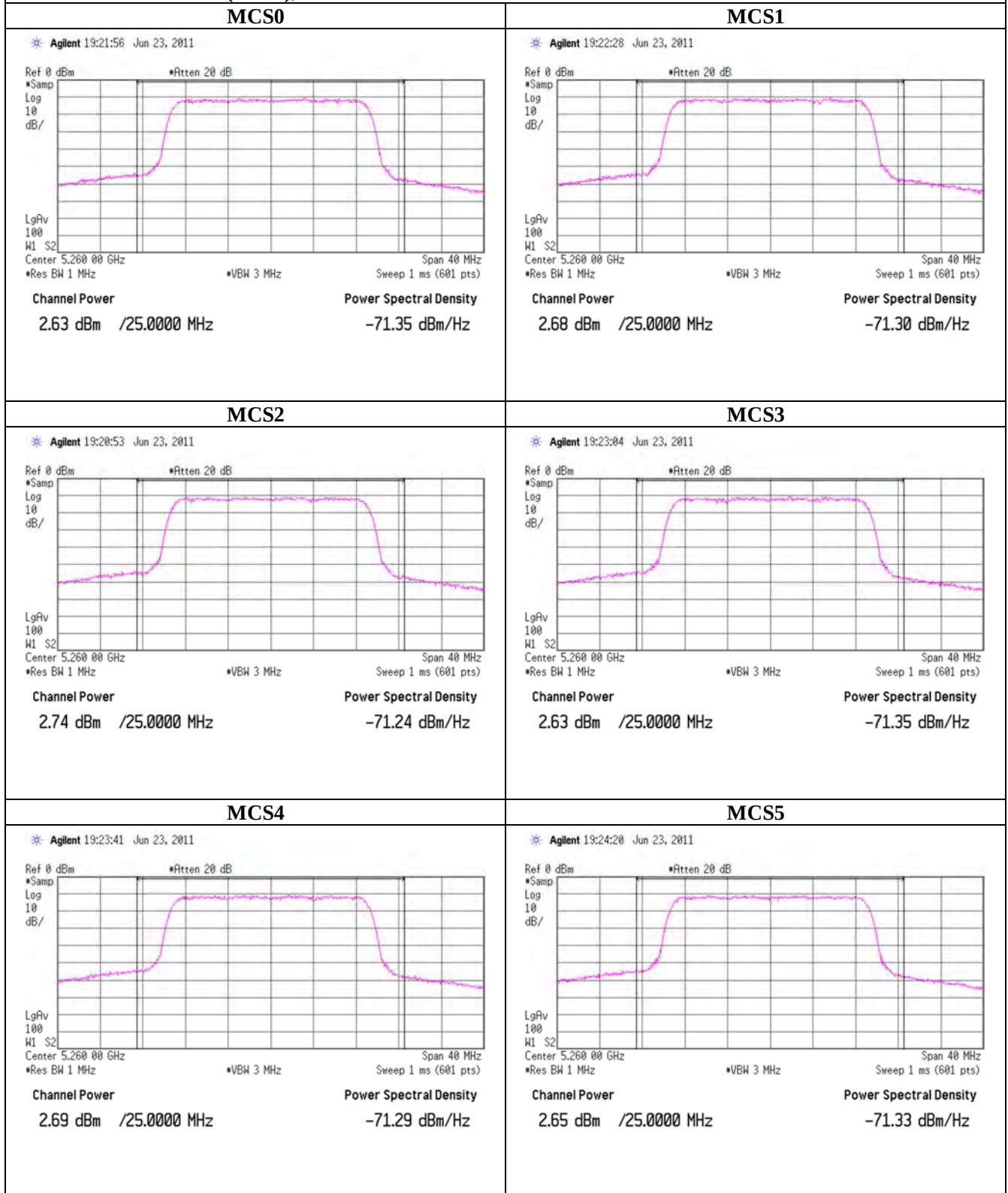
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

Peak Output Power (Conducted)**11n (HT20)****Tx, 5180MHz****Tx, 5200MHz****Tx, 5240MHz****Tx, 5260MHz****Tx, 5280MHz****Tx, 5320MHz**

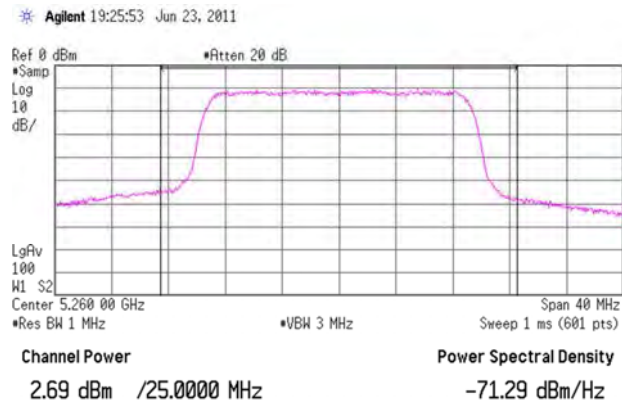
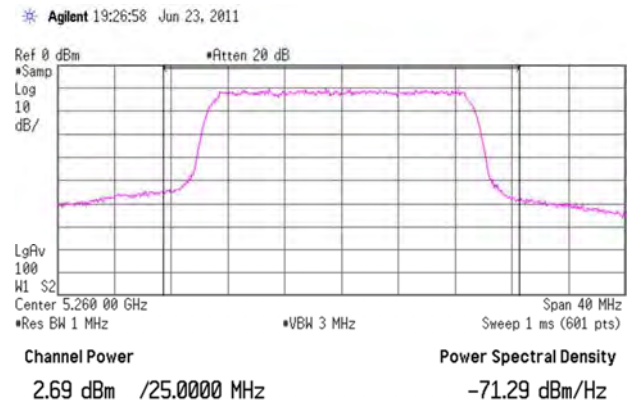
UL Japan, Inc.
Shonan EMC Lab.

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Telephone : +81 463 50 6400
Facsimile : +81 463 50 6401

Peak Output Power (Conducted)**11n (HT20), Reference chart Tx 5260 MHz**

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Shonan EMC Lab.

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Peak Output Power (Conducted)**11n (HT20), Reference chart Tx 5260 MHz****MCS6****MCS7**

UL Japan, Inc.
Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
 Telephone : +81 463 50 6400
 Facsimile : +81 463 50 6401

Peak Output Power (Conducted)

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 2011/5/19
 Temperature / Humidity 24deg.C. 49%RH
 Engineer Tatsuya Arai
 Mode 11n (HT40), Tx, Worst rate: MCS2

Ch	Freq. [MHz]	S/A (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low band, Low	5190.0	3.04	0.90	9.63	13.57	22.75	16.99	50.00	3.42
Low band, Mid	5230.0	2.71	0.90	9.62	13.23	21.04	16.99	50.00	3.76
Low band, High	-	-	-	-	-	-	-	-	-
Mid band, Low	5270.0	2.77	0.90	9.62	13.29	21.33	23.98	250.00	10.69
Mid band, Mid	5310.0	2.58	0.90	9.61	13.09	20.37	23.98	250.00	10.89
Mid band, High	-	-	-	-	-	-	-	-	-

Sample Calculation:

Result = Reading + Cable Loss (supplied by customer) + Atten. Loss

* In the above table, factor 0.0dB represents no use of Atten. and/or Filter.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

*Limit: Low band: 50mW, Mid band: 250mW

[Pre check]

Data Rate	Freq.	S/A (PK) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
0	5310.0	2.69	0.90	9.62	13.21	20.94	23.98	250.00	10.77
1	5270.0	2.70	0.90	9.62	13.22	20.99	23.98	250.00	10.76
2	5270.0	2.77	0.90	9.62	13.29	21.33	23.98	250.00	10.69
3	5270.0	2.76	0.90	9.62	13.28	21.28	23.98	250.00	10.70
4	5270.0	2.71	0.90	9.62	13.23	21.04	23.98	250.00	10.75
5	5270.0	2.75	0.90	9.62	13.27	21.23	23.98	250.00	10.71
6	5270.0	2.75	0.90	9.62	13.27	21.23	23.98	250.00	10.71
7	5270.0	2.75	0.90	9.62	13.27	21.23	23.98	250.00	10.71

Reference data for SAR testing

Data Rate	Freq.	P/M (PK) Reading [dBm]	P/M (AV) Reading [dBm]	loss [dB]	Result	
					PK [dBm]	AV [dBm]
0	5260.0	11.75	2.97	10.52	22.27	13.49
1	5260.0	11.77	2.97	10.52	22.29	13.49
2	5260.0	11.71	2.98	10.52	22.23	13.50
3	5260.0	12.38	2.94	10.52	22.90	13.46
4	5260.0	12.13	2.97	10.52	22.65	13.49
5	5260.0	12.35	2.96	10.52	22.87	13.48
6	5260.0	12.08	2.97	10.52	22.60	13.49
7	5260.0	11.73	2.93	10.52	22.25	13.45

S/A: Spectrum analyzer
 P/M: Power meter with Power sensor

UL Japan, Inc.
Shonan EMC Lab.

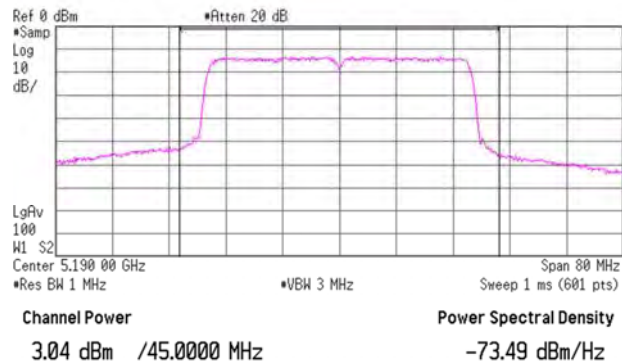
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

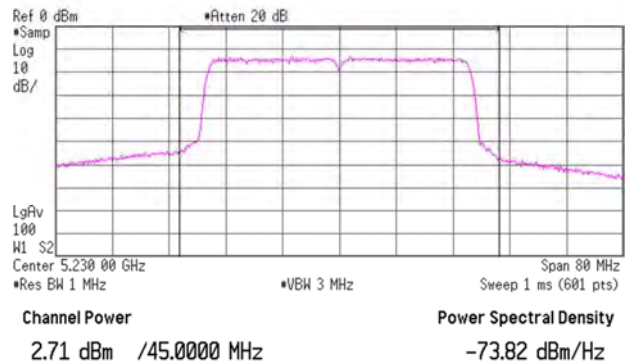
Facsimile : +81 463 50 6401

Peak Output Power (Conducted)**11n (HT40)****Tx, 5190MHz**

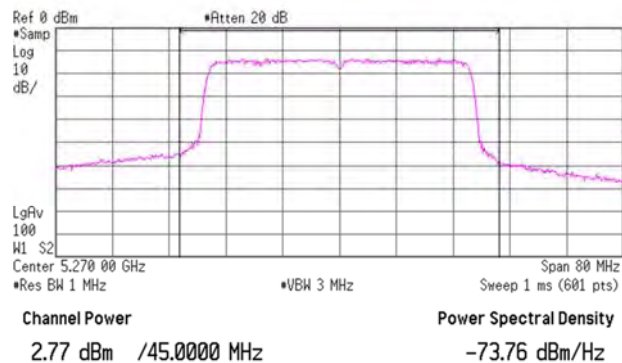
* Agilent 21:25:27 Jun 23, 2011

**Tx, 5230MHz**

* Agilent 21:27:05 Jun 23, 2011

**Tx, 5270MHz**

* Agilent 21:17:00 Jun 23, 2011

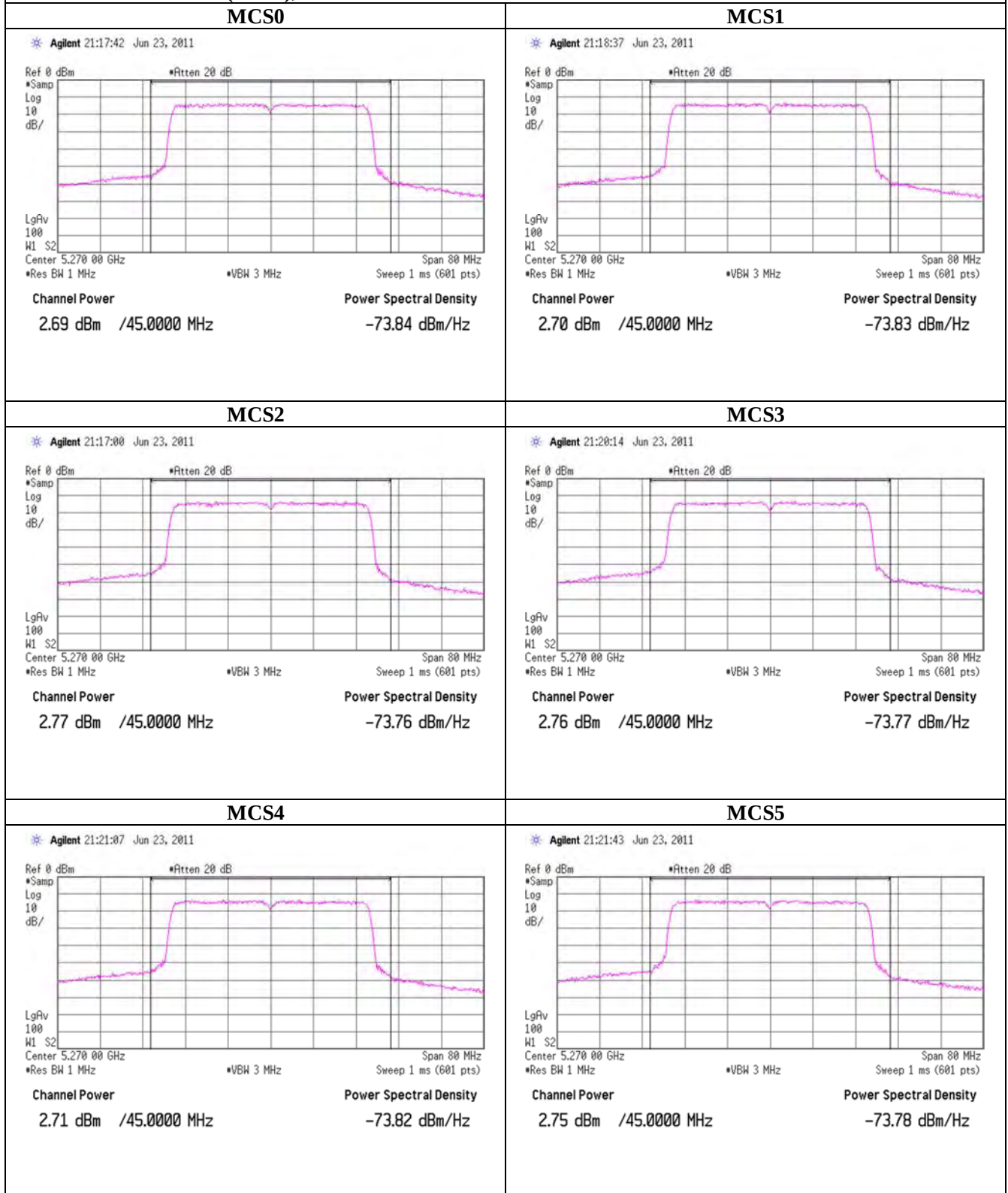
**Tx, 5310MHz**

* Agilent 21:29:59 Jun 23, 2011



UL Japan, Inc.
Shonan EMC Lab.

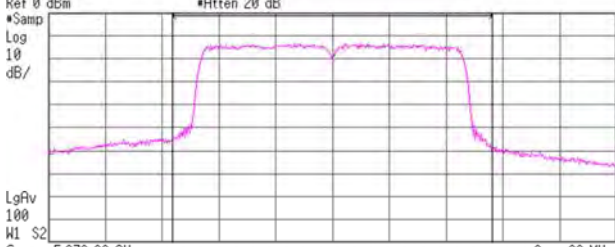
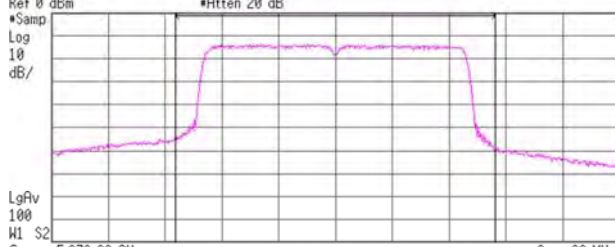
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
Telephone : +81 463 50 6400
Facsimile : +81 463 50 6401

Peak Output Power (Conducted)**11n (HT40), Reference chart Tx 5270 MHz**

UL Japan, Inc.
Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
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Facsimile : +81 463 50 6401

Peak Output Power (Conducted)

11n (HT40), Reference chart Tx 5270 MHz	
MCS6	MCS7
Agilent 21:22:48 Jun 23, 2011  Ref 0 dBm *Atten 20 dB Log 10 dB/ LgAv 100 HI S2 Center 5.270 00 GHz *Res BW 1 MHz Span 80 MHz Sweep 1 ms (601 pts) Channel Power 2.75 dBm /45.0000 MHz Power Spectral Density -73.78 dBm/Hz	Agilent 21:23:41 Jun 23, 2011  Ref 0 dBm *Atten 20 dB Log 10 dB/ LgAv 100 HI S2 Center 5.270 00 GHz *Res BW 1 MHz Span 80 MHz Sweep 1 ms (601 pts) Channel Power 2.75 dBm /45.0000 MHz Power Spectral Density -73.78 dBm/Hz

UL Japan, Inc.
Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
Telephone : +81 463 50 6400
Facsimile : +81 463 50 6401

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber	
Date	June 5, 2011	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	22deg.C. , 65%RH	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Shinichi Takano	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5180 MHz 11a, 6Mbps			

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.3	16.1	7.5	31.7	13.2	46.0	32.8	100	0	
Hori.	5150.000	PK	46.9	31.4	15.5	41.4	52.4	73.9	21.5	100	164	
Hori.	15540.000	PK	44.6	39.7	0.6	37.1	47.8	73.9	26.1	100	0	
Hori.	20720.000	PK	58.8	40.3	-2.7	47.4	49.0	73.9	24.9	100	97	
Hori.	5150.000	AV	35.1	31.4	15.5	41.4	40.6	53.9	13.3	100	164	VBW:10Hz
Hori.	15540.000	AV	33.9	39.7	0.6	37.1	37.1	53.9	16.8	100	0	VBW:10Hz
Hori.	20720.000	AV	47.5	40.3	-2.7	47.4	37.7	53.9	16.2	100	97	VBW:10Hz
Vert.	48.000	QP	22.0	12.2	7.2	31.9	9.5	40.0	30.5	100	0	
Vert.	5150.000	PK	46.4	31.4	15.5	41.4	51.9	73.9	22.0	109	133	
Vert.	15540.000	PK	44.7	39.7	0.6	37.1	47.9	73.9	26.0	100	0	
Vert.	20720.000	PK	54.3	40.3	-2.7	47.4	44.5	73.9	29.4	100	245	
Vert.	5150.000	AV	35.3	31.4	15.5	41.4	40.8	53.9	13.1	109	133	VBW:10Hz
Vert.	15540.000	AV	33.8	39.7	0.6	37.1	37.0	53.9	16.9	100	0	VBW:10Hz
Vert.	20720.000	AV	43.9	40.3	-2.7	47.4	34.1	53.9	19.8	100	245	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5200 MHz 11a, 6Mbps		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.5	16.1	7.5	31.7	13.4	46.0	32.6	100	0	
Hori.	15600.000	PK	43.7	39.5	0.7	37.1	46.8	73.9	27.1	100	0	
Hori.	20800.000	PK	60.9	40.3	-2.7	47.3	51.2	73.9	22.7	100	98	
Hori.	15600.000	AV	33.8	39.5	0.7	37.1	36.9	53.9	17.0	100	0	VBW:10Hz
Hori.	20800.000	AV	48.6	40.3	-2.7	47.3	38.9	53.9	15.0	100	98	VBW:10Hz
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15600.000	PK	45.0	39.5	0.7	37.1	48.1	73.9	25.8	100	0	
Vert.	20800.000	PK	55.4	40.3	-2.7	47.3	45.7	73.9	28.2	100	132	
Vert.	15600.000	AV	33.8	39.5	0.7	37.1	36.9	53.9	17.0	100	0	VBW:10Hz
Vert.	20800.000	AV	43.7	40.3	-2.7	47.3	34.0	53.9	19.9	100	132	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5240 MHz 11a, 6Mbps		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	15720.000	PK	43.8	39.2	0.8	37.2	46.6	73.9	27.3	100	0	
Hori.	20960.000	PK	56.2	40.3	-2.6	47.1	46.8	73.9	27.1	100	96	
Hori.	15720.000	AV	33.2	39.2	0.8	37.2	36.0	53.9	17.9	100	0	VBW:10Hz
Hori.	20960.000	AV	45.0	40.3	-2.6	47.1	35.6	53.9	18.3	100	96	VBW:10Hz
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15720.000	PK	44.3	39.2	0.8	37.2	47.1	73.9	26.8	100	0	
Vert.	20960.000	PK	50.0	40.3	-2.6	47.1	40.6	73.9	33.3	100	37	
Vert.	15720.000	AV	33.3	39.2	0.8	37.2	36.1	53.9	17.8	100	0	VBW:10Hz
Vert.	20960.000	AV	40.9	40.3	-2.6	47.1	31.5	53.9	22.4	100	37	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5260 MHz 11a, 6Mbps		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.2	13.0	8.3	31.8	11.7	43.5	31.8	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	15780.000	PK	46.6	39.0	0.8	37.2	49.2	73.9	24.7	100	0	
Hori.	21040.000	PK	57.8	40.4	-2.6	47.1	48.5	73.9	25.4	100	96	
Hori.	15780.000	AV	35.3	39.0	0.8	37.2	37.9	53.9	16.0	100	0	VBW:10Hz
Hori.	21040.000	AV	46.3	40.4	-2.6	47.1	37.0	53.9	16.9	100	96	VBW:10Hz
Vert.	48.000	QP	22.0	12.2	7.2	31.9	9.5	40.0	30.5	100	0	
Vert.	15780.000	PK	44.2	39.0	0.8	37.2	46.8	73.9	27.1	100	0	
Vert.	21040.000	PK	52.6	40.4	-2.6	47.1	43.3	73.9	30.6	100	34	
Vert.	15780.000	AV	33.6	39.0	0.8	37.2	36.2	53.9	17.7	100	0	VBW:10Hz
Vert.	21040.000	AV	41.7	40.4	-2.6	47.1	32.4	53.9	21.5	100	34	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 9, 2011 June 21, 2011 June 23, 2011	
Temperature / Humidity	23deg.C. , 64%RH 25deg.C. , 57%RH 25deg.C. , 58%RH	
Engineer	Tatsuya Arai Akio Hayashi Akio Hayashi	
Mode	Tx, 5280 MHz 11a, 6Mbps	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.2	13.0	8.3	31.8	11.7	43.5	31.8	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	15840.000	PK	45.9	38.9	0.9	37.2	48.5	73.9	25.4	100	0	
Hori.	21120.000	PK	57.6	40.4	-2.6	47.1	48.3	73.9	25.6	100	100	
Hori.	15840.000	AV	34.4	38.9	0.9	37.2	37.0	53.9	16.9	100	0	VBW:10Hz
Hori.	21120.000	AV	44.9	40.4	-2.6	47.1	35.6	53.9	18.3	100	100	VBW:10Hz
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15840.000	PK	45.2	38.9	0.9	37.2	47.8	73.9	26.1	100	0	
Vert.	21120.000	PK	51.4	40.4	-2.6	47.1	42.1	73.9	31.8	100	21	
Vert.	15840.000	AV	33.7	38.9	0.9	37.2	36.3	53.9	17.6	100	0	VBW:10Hz
Vert.	21120.000	AV	40.3	40.4	-2.6	47.1	31.0	53.9	22.9	100	21	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz $20\log(3.0\text{m}/1.0\text{m}) = 9.5\text{dB}$

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber			
Date	June 5, 2011	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	22deg.C. , 65%RH	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Shinichi Takano	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5320 MHz 11a, 6Mbps			

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	5350.000	PK	46.0	31.7	15.6	41.3	52.0	73.9	21.9	100	230	
Hori.	10640.000	PK	44.6	39.8	8.6	36.9	56.1	73.9	17.8	100	0	
Hori.	15960.000	PK	45.3	38.6	1.0	37.3	47.6	73.9	26.3	100	0	
Hori.	21280.000	PK	56.1	40.4	-2.6	47.0	46.9	73.9	27.0	100	99	
Hori.	5350.000	AV	34.4	31.7	15.6	41.3	40.4	53.9	13.5	100	230	VBW:10Hz
Hori.	10640.000	AV	33.1	39.8	8.6	36.9	44.6	53.9	9.3	100	0	VBW:10Hz
Hori.	15960.000	AV	33.7	38.6	1.0	37.3	36.0	53.9	17.9	100	0	VBW:10Hz
Hori.	21280.000	AV	42.7	40.4	-2.6	47.0	33.5	53.9	20.4	100	99	VBW:10Hz
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	5350.000	PK	44.8	31.7	15.6	41.3	50.8	73.9	23.1	134	113	
Vert.	10640.000	PK	44.9	39.8	8.6	36.9	56.4	73.9	17.5	100	0	
Vert.	15960.000	PK	43.5	38.6	1.0	37.3	45.8	73.9	28.1	100	0	
Vert.	21280.000	PK	50.0	40.4	-2.6	47.0	40.8	73.9	33.1	100	329	
Vert.	5350.000	AV	34.2	31.7	15.6	41.3	40.2	53.9	13.7	134	113	VBW:10Hz
Vert.	10640.000	AV	33.2	39.8	8.6	36.9	44.7	53.9	9.2	100	0	VBW:10Hz
Vert.	15960.000	AV	33.1	38.6	1.0	37.3	35.4	53.9	18.5	100	0	VBW:10Hz
Vert.	21280.000	AV	40.9	40.4	-2.6	47.0	31.7	53.9	22.2	100	329	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

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Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber	
Date	June 5, 2011	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	22deg.C. , 65%RH	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Shinichi Takano	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5180 MHz 11n (HT20), MCS2			

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	5150.000	PK	51.0	31.4	15.5	41.4	56.5	73.9	17.4	100	165	
Hori.	15540.000	PK	46.3	39.7	0.6	37.1	49.5	73.9	24.4	100	353	
Hori.	20720.000	PK	60.1	40.3	-2.7	47.4	50.3	73.9	23.6	100	98	
Hori.	5150.000	AV	38.8	31.4	15.5	41.4	44.3	53.9	9.6	100	165	VBW:10Hz
Hori.	15540.000	AV	35.7	39.7	0.6	37.1	38.9	53.9	15.0	100	353	VBW:10Hz
Hori.	20720.000	AV	46.8	40.3	-2.7	47.4	37.0	53.9	16.9	100	98	VBW:10Hz
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	5150.000	PK	47.8	31.4	15.5	41.4	53.3	73.9	20.6	109	136	
Vert.	15540.000	PK	46.5	39.7	0.6	37.1	49.7	73.9	24.2	100	8	
Vert.	20720.000	PK	52.9	40.3	-2.7	47.4	43.1	73.9	30.8	100	121	
Vert.	5150.000	AV	36.1	31.4	15.5	41.4	41.6	53.9	12.3	109	136	VBW:10Hz
Vert.	15540.000	AV	35.0	39.7	0.6	37.1	38.2	53.9	15.7	100	8	VBW:10Hz
Vert.	20720.000	AV	40.9	40.3	-2.7	47.4	31.1	53.9	22.8	100	121	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5200 MHz 11n (HT20), MCS2		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	15600.000	PK	46.2	39.5	0.7	37.1	49.3	73.9	24.6	100	47	
Hori.	20800.000	PK	59.5	40.3	-2.7	47.3	49.8	73.9	24.1	100	94	
Hori.	15600.000	AV	33.9	39.5	0.7	37.1	37.0	53.9	16.9	100	47	VBW:10Hz
Hori.	20800.000	AV	46.8	40.3	-2.7	47.3	37.1	53.9	16.8	100	94	VBW:10Hz
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15600.000	PK	44.7	39.5	0.7	37.1	47.8	73.9	26.1	100	8	
Vert.	20800.000	PK	50.5	40.3	-2.7	47.3	40.8	73.9	33.1	100	286	
Vert.	15600.000	AV	34.0	39.5	0.7	37.1	37.1	53.9	16.8	100	8	VBW:10Hz
Vert.	20800.000	AV	41.1	40.3	-2.7	47.3	31.4	53.9	22.5	100	286	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5240 MHz 11n (HT20), MCS2		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	15720.000	PK	48.2	39.2	0.8	37.2	51.0	73.9	22.9	100	2	
Hori.	20960.000	PK	63.1	40.3	-2.6	47.1	53.7	73.9	20.2	100	86	
Hori.	15720.000	AV	36.4	39.2	0.8	37.2	39.2	53.9	14.7	100	2	
Hori.	20960.000	AV	51.0	40.3	-2.6	47.1	41.6	53.9	12.3	100	86	
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15720.000	PK	46.0	39.2	0.8	37.2	48.8	73.9	25.1	100	8	
Vert.	20960.000	PK	53.3	40.3	-2.6	47.1	43.9	73.9	30.0	100	119	
Vert.	15720.000	AV	35.3	39.2	0.8	37.2	38.1	53.9	15.8	100	8	
Vert.	20960.000	AV	43.8	40.3	-2.6	47.1	34.4	53.9	19.5	100	119	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5260 MHz 11n (HT20), MCS2		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.2	13.0	8.3	31.8	11.7	43.5	31.8	100	0	
Hori.	384.000	QP	21.5	16.1	7.5	31.7	13.4	46.0	32.6	100	0	
Hori.	15780.000	PK	45.2	39.0	0.8	37.2	47.8	73.9	26.1	100	0	
Hori.	21040.000	PK	56.7	40.4	-2.6	47.1	47.4	73.9	26.5	100	98	
Hori.	15780.000	AV	34.2	39.0	0.8	37.2	36.8	53.9	17.1	100	0	
Hori.	21040.000	AV	44.0	40.4	-2.6	47.1	34.7	53.9	19.2	100	98	
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15780.000	PK	45.0	39.0	0.8	37.2	47.6	73.9	26.3	100	0	
Vert.	21040.000	PK	48.4	40.4	-2.6	47.1	39.1	73.9	34.8	100	274	
Vert.	15780.000	AV	33.5	39.0	0.8	37.2	36.1	53.9	17.8	100	0	
Vert.	21040.000	AV	40.5	40.4	-2.6	47.1	31.2	53.9	22.7	100	274	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5280 MHz 11n (HT20), MCS2		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	15840.000	PK	44.7	38.9	0.9	37.2	47.3	73.9	26.6	100	0	
Hori.	21120.000	PK	56.5	40.4	-2.6	47.1	47.2	73.9	26.7	100	103	
Hori.	15840.000	AV	33.9	38.9	0.9	37.2	36.5	53.9	17.4	100	0	
Hori.	21120.000	AV	44.0	40.4	-2.6	47.1	34.7	53.9	19.2	100	103	
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15840.000	PK	45.0	38.9	0.9	37.2	47.6	73.9	26.3	100	0	
Vert.	21120.000	PK	49.4	40.4	-2.6	47.1	40.1	73.9	33.8	100	39	
Vert.	15840.000	AV	33.4	38.9	0.9	37.2	36.0	53.9	17.9	100	0	
Vert.	21120.000	AV	39.8	40.4	-2.6	47.1	30.5	53.9	23.4	100	39	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber	
Date	June 5, 2011	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	22deg.C. , 65%RH	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Shinichi Takano	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5320 MHz 11n (HT20), MCS2			

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.5	16.1	7.5	31.7	13.4	46.0	32.6	100	0	
Hori.	5350.000	PK	45.7	31.7	15.6	41.3	51.7	73.9	22.2	100	300	
Hori.	10640.000	PK	44.3	39.8	8.6	36.9	55.8	73.9	18.1	100	0	
Hori.	15960.000	PK	43.6	38.6	1.0	37.3	45.9	73.9	28.0	100	0	
Hori.	21280.000	PK	54.7	40.4	-2.6	47.0	45.5	73.9	28.4	100	97	
Hori.	5350.000	AV	34.4	31.7	15.6	41.3	40.4	53.9	13.5	100	300	
Hori.	10640.000	AV	33.1	39.8	8.6	36.9	44.6	53.9	9.3	100	0	
Hori.	15960.000	AV	33.1	38.6	1.0	37.3	35.4	53.9	18.5	100	0	
Hori.	21280.000	AV	42.0	40.4	-2.6	47.0	32.8	53.9	21.1	100	97	
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	5350.000	PK	45.6	31.7	15.6	41.3	51.6	73.9	22.3	134	156	
Vert.	10640.000	PK	44.7	39.8	8.6	36.9	56.2	73.9	17.7	100	0	
Vert.	15960.000	PK	43.1	38.6	1.0	37.3	45.4	73.9	28.5	100	0	
Vert.	21280.000	PK	48.4	40.4	-2.6	47.0	39.2	73.9	34.7	100	333	
Vert.	5350.000	AV	34.4	31.7	15.6	41.3	40.4	53.9	13.5	134	156	
Vert.	10640.000	AV	33.2	39.8	8.6	36.9	44.7	53.9	9.2	100	0	
Vert.	15960.000	AV	32.8	38.6	1.0	37.3	35.1	53.9	18.8	100	0	
Vert.	21280.000	AV	40.6	40.4	-2.6	47.0	31.4	53.9	22.5	100	333	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber			
Date	June 5, 2011	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	22deg.C. , 65%RH	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Shinichi Takano	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5190 MHz 11n (HT40), MCS2			

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.4	16.1	7.5	31.7	13.3	46.0	32.7	100	0	
Hori.	5150.000	PK	46.3	31.4	15.5	41.4	51.8	73.9	22.1	100	165	
Hori.	15570.000	PK	45.8	39.6	0.6	37.1	48.9	73.9	25.0	100	0	
Hori.	20760.000	PK	54.5	40.3	-2.7	47.4	44.7	73.9	29.2	100	96	
Hori.	5150.000	AV	35.2	31.4	15.5	41.4	40.7	53.9	13.2	100	165	VBW:10Hz
Hori.	15570.000	AV	35.6	39.6	0.6	37.1	38.7	53.9	15.2	100	0	VBW:10Hz
Hori.	20760.000	AV	43.5	40.3	-2.7	47.4	33.7	53.9	20.2	100	96	VBW:10Hz
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	5150.000	PK	47.3	31.4	15.5	41.4	52.8	73.9	21.1	109	136	
Vert.	15570.000	PK	46.4	39.6	0.6	37.1	49.5	73.9	24.4	100	0	
Vert.	20760.000	PK	50.1	40.3	-2.7	47.4	40.3	73.9	33.6	100	79	
Vert.	5150.000	AV	35.1	31.4	15.5	41.4	40.6	53.9	13.3	109	136	VBW:10Hz
Vert.	15570.000	AV	34.5	39.6	0.6	37.1	37.6	53.9	16.3	100	0	VBW:10Hz
Vert.	20760.000	AV	40.9	40.3	-2.7	47.4	31.1	53.9	22.8	100	79	VBW:10Hz

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5230 MHz 11n (HT40), MCS2		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.1	13.0	8.3	31.8	11.6	43.5	31.9	100	0	
Hori.	384.000	QP	21.5	16.1	7.5	31.7	13.4	46.0	32.6	100	0	
Hori.	15690.000	PK	45.2	39.3	0.8	37.2	48.1	73.9	25.8	100	0	
Hori.	20920.000	PK	52.7	40.3	-2.6	47.2	43.2	73.9	30.7	100	96	
Hori.	15690.000	AV	34.0	39.3	0.8	37.2	36.9	53.9	17.0	100	0	
Hori.	20920.000	AV	41.5	40.3	-2.6	47.2	32.0	53.9	21.9	100	96	
Vert.	48.000	QP	22.2	12.2	7.2	31.9	9.7	40.0	30.3	100	0	
Vert.	15690.000	PK	43.8	39.3	0.8	37.2	46.7	73.9	27.2	100	0	
Vert.	20920.000	PK	49.7	40.3	-2.6	47.2	40.2	73.9	33.7	100	17	
Vert.	15690.000	AV	33.5	39.3	0.8	37.2	36.4	53.9	17.5	100	0	
Vert.	20920.000	AV	40.5	40.3	-2.6	47.2	31.0	53.9	22.9	100	17	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber
Date	June 9, 2011	June 21, 2011	June 23, 2011
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH
Engineer	Tatsuya Arai	Akio Hayashi	Akio Hayashi
Mode	Tx, 5270 MHz 11n (HT40), MCS2		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.2	13.0	8.3	31.8	11.7	43.5	31.8	100	0	
Hori.	384.000	QP	21.5	16.1	7.5	31.7	13.4	46.0	32.6	100	0	
Hori.	15810.000	PK	44.1	39.0	0.9	37.2	46.8	73.9	27.1	100	0	
Hori.	21080.000	PK	51.4	40.4	-2.6	47.1	42.1	73.9	31.8	100	108	
Hori.	15810.000	AV	33.4	39.0	0.9	37.2	36.1	53.9	17.8	100	0	
Hori.	21080.000	AV	41.1	40.4	-2.6	47.1	31.8	53.9	22.1	100	108	
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	15810.000	PK	43.2	39.0	0.9	37.2	45.9	73.9	28.0	100	0	
Vert.	21080.000	PK	47.6	40.4	-2.6	47.1	38.3	73.9	35.6	100	331	
Vert.	15810.000	AV	33.2	39.0	0.9	37.2	35.9	53.9	18.0	100	0	
Vert.	21080.000	AV	40.0	40.4	-2.6	47.1	30.7	53.9	23.2	100	331	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Radiated Emission (below 1GHz and above 1GHz Inside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.		No.3 Semi Anechoic Chamber			
Date	June 5, 2011	June 8, 2011	June 9, 2011	June 21, 2011	June 23, 2011	
Temperature / Humidity	22deg.C. , 65%RH	23deg.C. , 64%RH	23deg.C. , 64%RH	25deg.C. , 57%RH	25deg.C. , 58%RH	
Engineer	Shinichi Takano	Tatsuya Arai	Tatsuya Arai	Akio Hayashi	Akio Hayashi	
Mode	Tx, 5310 MHz 11n (HT40), MCS2					

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	128.000	QP	22.3	13.0	8.3	31.8	11.8	43.5	31.7	100	0	
Hori.	384.000	QP	21.5	16.1	7.5	31.7	13.4	46.0	32.6	100	0	
Hori.	5350.000	PK	48.2	31.7	15.6	41.3	54.2	73.9	19.7	100	300	
Hori.	10620.000	PK	43.9	39.8	8.6	36.8	55.5	73.9	18.4	100	0	
Hori.	15930.000	PK	43.5	38.6	1.0	37.3	45.8	73.9	28.1	100	0	
Hori.	21240.000	PK	52.5	40.4	-2.6	47.0	43.3	73.9	30.6	100	97	
Hori.	5350.000	AV	34.7	31.7	15.6	41.3	40.7	53.9	13.2	100	300	
Hori.	10620.000	AV	33.0	39.8	8.6	36.8	44.6	53.9	9.3	100	0	
Hori.	15930.000	AV	32.9	38.6	1.0	37.3	35.2	53.9	18.7	100	0	
Hori.	21240.000	AV	41.0	40.4	-2.6	47.0	31.8	53.9	22.1	100	97	
Vert.	48.000	QP	22.1	12.2	7.2	31.9	9.6	40.0	30.4	100	0	
Vert.	5350.000	PK	47.2	31.7	15.6	41.3	53.2	73.9	20.7	147	156	
Vert.	10620.000	PK	44.0	39.8	8.6	36.8	55.6	73.9	18.3	100	0	
Vert.	15930.000	PK	42.8	38.6	1.0	37.3	45.1	73.9	28.8	100	0	
Vert.	21240.000	PK	49.5	40.4	-2.6	47.0	40.3	73.9	33.6	100	22	
Vert.	5350.000	AV	34.9	31.7	15.6	41.3	40.9	53.9	13.0	147	156	
Vert.	10620.000	AV	33.1	39.8	8.6	36.8	44.7	53.9	9.2	100	0	
Vert.	15930.000	AV	32.7	38.6	1.0	37.3	35.0	53.9	18.9	100	0	
Vert.	21240.000	AV	39.8	40.4	-2.6	47.0	30.6	53.9	23.3	100	22	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 7, 2011	June 21, 2011	
Temperature / Humidity	24deg.C. , 60%RH	25deg.C. , 57%RH	
Engineer	Tatsuya Arai	Akio Hayashi	
Mode	Tx,	5180 MHz	
	11a, 6Mbps		

[illegible]
$$\text{Result[dBuV/m]} = \text{Reading} + \text{Ant Factor} + \text{Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz))} - \text{Gain(Amplifier)}$$
$$\text{Result(EIRP[dBm])} = 10 * \text{LOG}((10^{(\text{Electric Field Strength [dBuV/m] / 20)} * 10^{(-6)} * \text{Distance:3[m]})^2 / 30) * 10^3)$$

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz $20\log(3.0\text{m}/1.0\text{m})= 9.5\text{dB}$

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 7, 2011	June 21, 2011	
Temperature / Humidity	24deg.C. , 60%RH	25deg.C. , 57%RH	
Engineer	Tatsuya Arai	Akio Hayashi	
Mode	Tx,	5200 MHz	
	11a, 6Mbps		

[illegible]
$$\text{Result[dBuV/m]} = \text{Reading} + \text{Ant Factor} + \text{Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz))} - \text{Gain(Amplifier)}$$
$$\text{Result(EIRP[dBm])} = 10 * \text{LOG}((10^{(\text{Electric Field Strength [dBuV/m] / 20)} * 10^{(-6)} * \text{Distance:3[m]})^2 / 30) * 10^3)$$

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz $20\log(3.0\text{m}/1.0\text{m})= 9.5\text{dB}$

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber
Date June 7, 2011 June 21, 2011
Temperature / Humidity 24deg.C. , 60%RH 25deg.C. , 57%RH
Engineer Tatsuya Arai Akio Hayashi
Mode Tx, 5240 MHz
11a, 6Mbps

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Result (EIRP [dBm])	Limit [dBm]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	10480.000	PK	44.8	39.6	8.5	36.6	56.3	-38.9	-27.0	11.9	100	0	
Hori.	26200.000	PK	46.7	40.4	-1.4	46.9	38.8	-56.4	-27.0	29.4	100	0	
Vert.	10480.000	PK	44.7	39.6	8.5	36.6	56.2	-39.0	-27.0	12.0	100	0	
Vert.	26200.000	PK	47.0	40.4	-1.4	46.9	39.1	-56.1	-27.0	29.1	100	0	

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30) *10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 8, 2011	June 21, 2011	
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	
Engineer	Akio Hayashi	Akio Hayashi	
Mode	Tx, 5260 MHz		
	11a, 6Mbps		

[illegible]

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBUV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30) *10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 8, 2011	June 21, 2011	
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	
Engineer	Akio Hayashi	Akio Hayashi	
Mode	Tx, 5280 MHz		
	11a, 6Mbps		

[illegible]

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result[EIRP[dBm] = $10 * \log(\{ (10^4 * \text{Electric Field Strength [dBuV/m]} / 20) * 10^{(-6)} * \text{Distance:3[m]} \}^2 / 30) + 10^{(3)}$

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz $20\log(3.0\text{m}/1.0\text{m}) = 9.5\text{dB}$

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber
Date June 8, 2011 June 22, 2011
Temperature / Humidity 23deg.C. , 64%RH 25deg.C. , 56%RH
Engineer Akio Hayashi Akio Hayashi
Mode Tx, 5320 MHz
11a, 6Mbps

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Result (EIRP [dBm])	Limit [dBm]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	7092.000	PK	44.6	36.0	7.0	38.4	49.2	-46.0	-27.0	19.0	100	0	
Hori.	26600.000	PK	62.0	43.0	3.2	68.6	39.6	-55.6	-27.0	28.6	100	0	
Vert.	7092.000	PK	45.2	36.0	7.0	38.4	49.8	-45.4	-27.0	18.4	100	0	
Vert.	26600.000	PK	61.2	43.0	3.2	68.6	38.8	-56.4	-27.0	29.4	100	0	

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30) *10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 8, 2011	June 21, 2011	
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	
Engineer	Akio Hayashi	Akio Hayashi	
Mode	Tx,	5180 MHz	
	11n (HT20), MCS2		

[illegible]

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result[EIRP[dBm]]=10*LOG(((10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2) / 30)*10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 8, 2011	June 21, 2011	
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	
Engineer	Akio Hayashi	Akio Hayashi	
Mode	Tx,	5200 MHz	
	11n (HT20), MCS2		

[illegible]

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result[EIRP[dBm] = 10*LOG(((10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:[m]) ^ 2) / 30) * 10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber
Date June 8, 2011 June 21, 2011
Temperature / Humidity 23deg.C. , 64%RH 25deg.C. , 57%RH
Engineer Akio Hayashi Akio Hayashi
Mode Tx, 5240 MHz
11n (HT20), MCS2

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Result (EIRP [dBm])	Limit [dBm]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	10480.000	PK	45.3	39.6	8.5	36.6	56.8	-38.4	-27.0	11.4	100	0	
Hori.	26200.000	PK	47.8	40.4	-1.4	46.9	39.9	-55.3	-27.0	28.3	100	0	
Vert.	10480.000	PK	44.3	39.6	8.5	36.6	55.8	-39.4	-27.0	12.4	100	0	
Vert.	26200.000	PK	47.2	40.4	-1.4	46.9	39.3	-55.9	-27.0	28.9	100	0	

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30) *10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 8, 2011	June 21, 2011	
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	
Engineer	Akio Hayashi	Akio Hayashi	
Mode	Tx,	5260 MHz	
	11n (HT20), MCS2		

[illegible]
$$\text{Result[dBuV/m]} = \text{Reading} + \text{Ant Factor} + \text{Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz))} - \text{Gain(Amplifier)}$$
$$\text{Result(EIRP[dBm])} = 10 * \text{LOG}((10^{(\text{Electric Field Strength [dBuV/m] / 20)} * 10^{(-6)} * \text{Distance:3[m]})^2 / 30) * 10^3)$$

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz $20\log(3.0\text{m}/1.0\text{m})= 9.5\text{dB}$

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber
Date June 8, 2011 June 21, 2011
Temperature / Humidity 23deg.C. , 64%RH 25deg.C. , 57%RH
Engineer Akio Hayashi Akio Hayashi
Mode Tx, 5280 MHz
11n (HT20), MCS2

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Result (EIRP [dBm])	Limit [dBm]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	7042.000	PK	46.7	35.9	7.0	38.4	51.2	-44.0	-27.0	17.0	100	0	
Hori.	10560.000	PK	44.3	39.7	8.5	36.7	55.8	-39.4	-27.0	12.4	100	0	
Hori.	26400.000	PK	46.5	40.1	-1.4	46.9	38.3	-56.9	-27.0	29.9	100	0	
Vert.	7042.000	PK	46.0	35.9	7.0	38.4	50.5	-44.7	-27.0	17.7	100	0	
Vert.	10560.000	PK	45.1	39.7	8.5	36.7	56.6	-38.6	-27.0	11.6	100	0	
Vert.	26400.000	PK	45.9	40.1	-1.4	46.9	37.7	-57.5	-27.0	30.5	100	0	

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30) *10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber
Date June 8, 2011 June 22, 2011
Temperature / Humidity 23deg.C. , 64%RH 25deg.C. , 56%RH
Engineer Akio Hayashi Akio Hayashi
Mode Tx, 5320 MHz
11n (HT20), MCS2

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Result (EIRP [dBm])	Limit [dBm]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	7092.000	PK	45.7	36.0	7.0	38.4	50.3	-44.9	-7.0	37.9	100	0	
Hori.	26600.000	PK	60.7	43.0	3.2	68.6	38.3	-56.9	-7.0	49.9	100	0	
Vert.	7092.000	PK	46.2	36.0	7.0	38.4	50.8	-44.4	-7.0	37.4	100	0	
Vert.	26600.000	PK	61.7	43.0	3.2	68.6	39.3	-55.9	-7.0	48.9	100	0	

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30) *10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 8, 2011	June 21, 2011	
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	
Engineer	Akio Hayashi	Akio Hayashi	
Mode	Tx,	5190 MHz	
	11n (HT40), MCS2		

[illegible]
$$\text{Result[dBuV/m]} = \text{Reading} + \text{Ant Factor} + \text{Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz))} - \text{Gain(Amplifier)}$$
$$\text{Result(EIRP[dBm])} = 10 * \text{LOG}((10^{(\text{Electric Field Strength [dBuV/m] / 20)} * 10^{(-6)} * \text{Distance:3[m]})^2 / 30) * 10^3)$$

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz $20\log(3.0\text{m}/1.0\text{m})= 9.5\text{dB}$

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place UL Japan, Inc. Shonan EMC Lab. No.3 Semi Anechoic Chamber
Date June 8, 2011 June 21, 2011
Temperature / Humidity 23deg.C. , 64%RH 25deg.C. , 57%RH
Engineer Akio Hayashi Akio Hayashi
Mode Tx, 5230 MHz
11n (HT40), MCS2

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Result (EIRP [dBm])	Limit [dBm]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	10460.000	PK	45.2	39.6	8.5	36.6	56.7	-38.53	-27.0	11.5	100	0	
Hori.	26150.000	PK	46.5	40.5	-1.4	46.8	38.8	-56.43	-27.0	29.4	100	0	
Vert.	10460.000	PK	44.6	39.6	8.5	36.6	56.1	-39.13	-27.0	12.1	100	0	
Vert.	26150.000	PK	47.5	40.5	-1.4	46.8	39.8	-55.43	-27.0	28.4	100	0	

Result[dBuV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBuV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30) *10^3)

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc.	Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 8, 2011	June 21, 2011	
Temperature / Humidity	23deg.C. , 64%RH	25deg.C. , 57%RH	
Engineer	Tatsuya Arai	Akio Hayashi	
Mode	Tx, 5270 MHz		
	11n (HT40), MCS2		

[illegible]
$$\text{Result[dBuV/m]} = \text{Reading} + \text{Ant Factor} + \text{Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz))} - \text{Gain(Amplifier)}$$
$$\text{Result(EIRP[dBm])} = 10 * \text{LOG}((10^{(\text{Electric Field Strength [dBuV/m] / 20)} * 10^{(-6)} * \text{Distance:3[m]})^2 / 30) * 10^3)$$

*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz $20\log(3.0\text{m}/1.0\text{m})= 9.5\text{dB}$

Data of Spurious Emissions (Calculation)(above 1GHz Outside of the restricted band)

Test place	UL Japan, Inc. Shonan EMC Lab.	No.3 Semi Anechoic Chamber
Date	June 22, 2011	
Temperature / Humidity	25deg.C. , 56%RH	
Engineer	Akio Hayashi	
Mode	Tx, 5310 MHz	
	11n (HT40), MCS2	

[illegible]

Result[dBµV/m] = Reading + Ant Factor + Loss (Cable+Attenuator+Filter-Distance factor(above 13GHz)) - Gain(Amplifier)

Result(EIRP[dBm])=10*LOG(({ 10 ^ (Electric Field Strength [dBµV/m] / 20) * 10 ^ (-6) * Distance:3[m]) ^ 2 } / 30)*10^3)

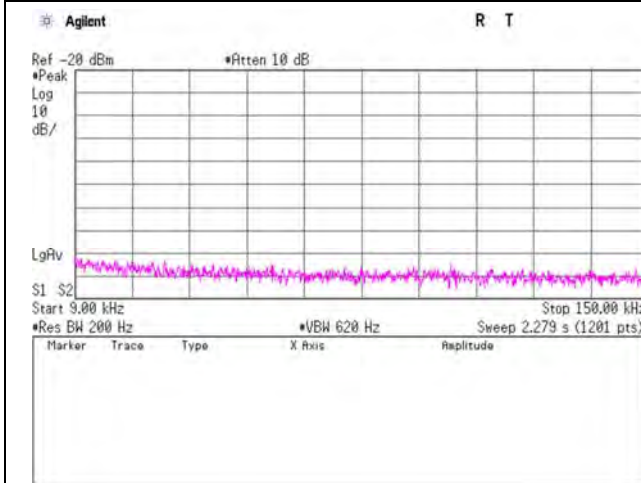
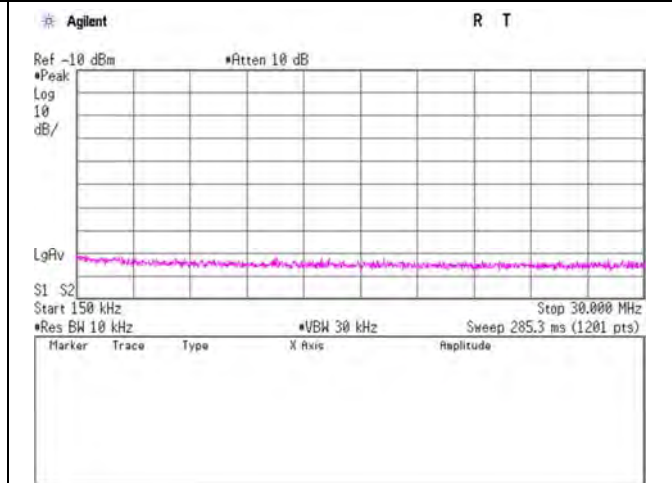
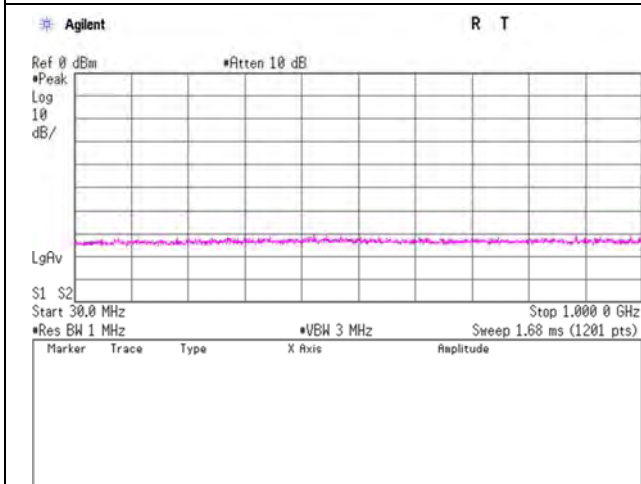
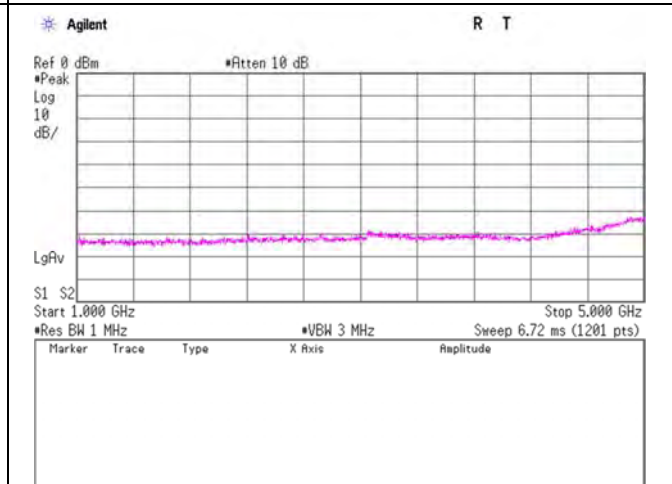
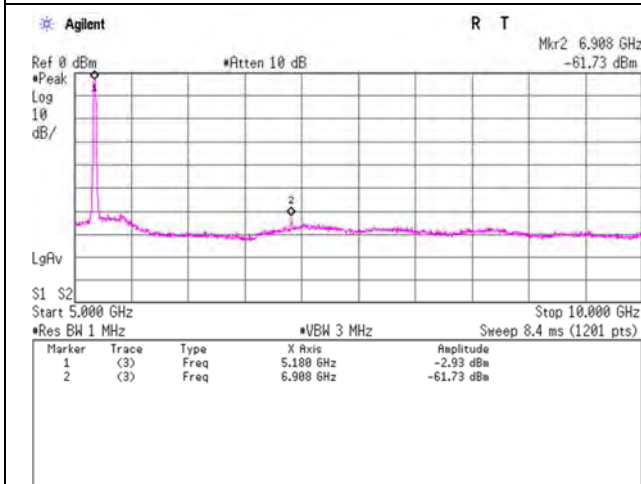
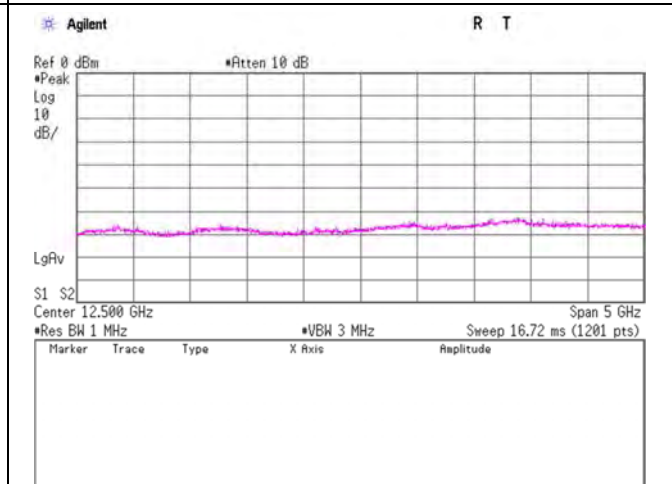
*Other frequency noises omitted in this report were not seen or have enough margin (more than 20dB).

Distance factor: 13GHz-40GHz 20log(3.0m/1.0m)= 9.5dB

Spurious emission (Conducted)

11a

Tx, 5180MHz

9kHz - 150kHz**150kHz - 30MHz****30MHz - 1GHz****1GHz - 5GHz****5GHz - 10GHz****10GHz - 15GHz**

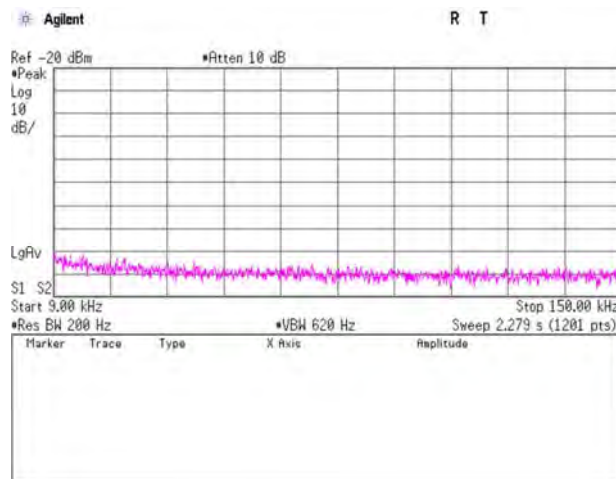
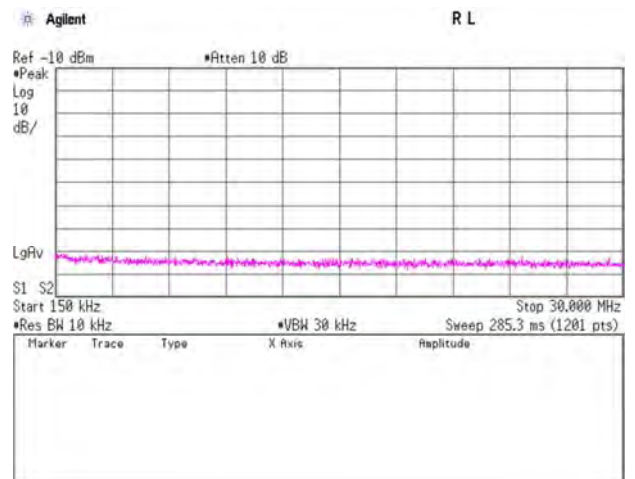
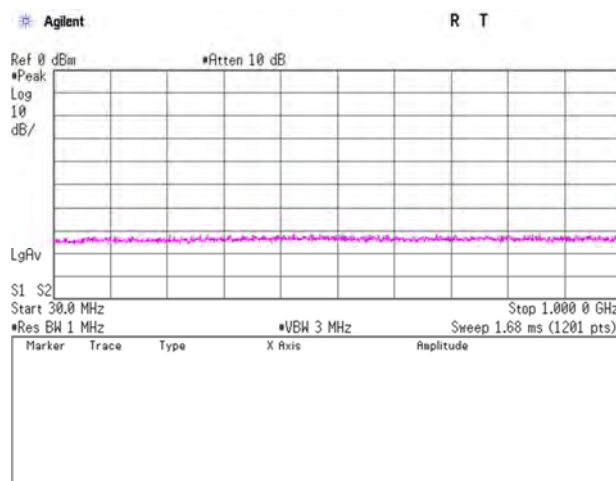
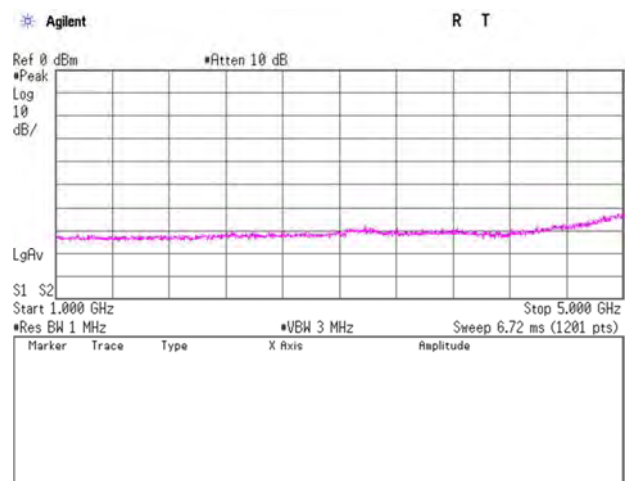
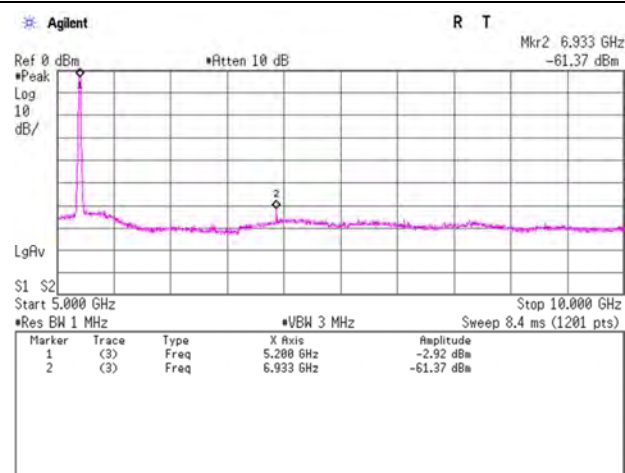
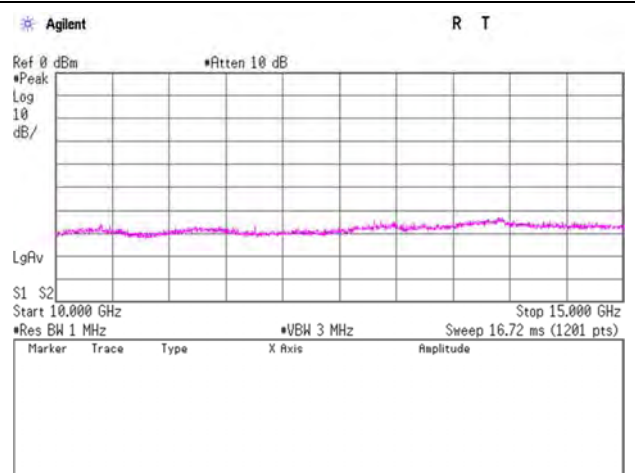
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Spurious emission (Conducted)

11a

Tx, 5200MHz

9kHz - 150kHz**150kHz - 30MHz****30MHz - 1GHz****1GHz - 5GHz****5GHz - 10GHz****10GHz - 15GHz**

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Spurious emission (Conducted)

11a

Tx, 5200MHz

